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: DIELECTRIC CERAMIC COMPOSITION

AND LAMINATED CERAMIC CAPACITOR

USING THE SAME

: Murata Manufacturing Co., Ltd. Assignee

Enclosed herewith please find the following documents in the above-identified application for United States Letters Patent:

<u>67</u> Pages of Specification including Abstract and Claims	
20 Numbered Claims Calculated as 20 Claims for Fee Purposes	
Sheets of Drawing Containing Figures / to 7 . (Formal/Informa	1)
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DIELECTRIC CERAMIC COMPOSITION AND LAMINATED CERAMIC CAPACITOR USING THE SAME

BACKGROUND OF THE INVENTION

1. Field of the Invention

The present invention relates to a dielectric ceramic composition and a laminated ceramic capacitor using the same, especially to a ceramic capacitor having inner electrodes made of Ni.

2. Description of the Related Art

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Ceramic layers and inner electrode metal layers are alternately stacked in the laminated ceramic capacitor. A cheap base metal such as Ni has been recently used for the inner electrodes in place of expensive noble metals such as Aq and Pd for reducing the production cost. When Ni is used for the electrodes, the capacitor should be fired in a reducing atmosphere where Ni is not oxidized. However, ceramics comprising barium titanate as a principal component may be endowed with semiconductive properties when the ceramics are fired in a reducing atmosphere. Accordingly, as disclosed for example in Japanese Examined Patent Publication No. 57-42588, a dielectric material in which the ratio between the barium site and titanium site in the barium titanate solid solution is adjusted to be larger than the stoichiometric ratio has been developed. This allows the laminated ceramic capacitor using Ni as electrodes to be

Since electronic parts have been rapidly miniaturized with the recent advance of electronics,

practically used, thereby expanding its production scale.

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small size ceramic capacitors with large capacitance as well as temperature stability of electrostatic capacitance are required. The ceramic capacitors having the Ni electrodes are also under the same circumstances.

For complying with the requirements of large capacitance and small size, the dielectric ceramics should be made to be thinner and multi-layered. However, much higher voltage is impressed on the dielectric material when the dielectric ceramic layer is thinned, often causing troubles such as decrease of dielectric constant, increase of temperature dependency of the electrostatic capacitance and deteriorated stability of other characteristics when conventional dielectric materials are used. Especially, when the thickness of the dielectric layer is reduced to 5 $\mu \rm m$ or less, 10 or less ceramic particles are contained between the inner electrodes, making it difficult to assure a stable quality.

Making the dielectric layer thin is accompanied by other problems. Solder plating layers as external electrodes are usually formed on the baked electrodes of a conductive metal powder in order to comply with automatic packaging of the laminated ceramic capacitor. Therefore, the plating layer is generally formed by electroplating. Oxides containing boron or a glass is added, on the other hand, into some dielectric ceramics as a sintering aid. However, the dielectric ceramic using these additives has so poor resistance against plating that characteristics of the laminated ceramic capacitor may be deteriorated by dipping it into a plating solution. It has been a problem that reliability is markedly decreased in the ceramic capacitor having thin dielectric ceramic layers.

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SUMMARY OF THE INVENTION

Accordingly, the object of the present invention is to provide a laminated ceramic capacitor with high reliability and large capacitance especially using Ni for inner electrodes, wherein dielectric constant is not decreased exhibiting a stable electrostatic capacitance even when the dielectric ceramic layers are thinned, and temperature characteristics of the electrostatic capacitance satisfy the B-grade characteristics prescribed in the JIS standard and the X7R-grade characteristics prescribed in the EIA standard.

The present invention also provides a highly reliable laminated ceramic capacitor with large capacitance made of thin dielectric ceramic layers having an excellent plating solution resistance.

In one aspect, the present invention provides a laminated ceramic capacitor provided with a plurality of dielectric ceramic layers, inner electrodes formed between the dielectric ceramic layers and external electrodes being in electrical continuity with the inner electrodes, the dielectric ceramic layer being represented by the following formula:

 $(\text{Ba}_{1\text{-x}}\text{Ca}_{x}\text{O})_{\text{m}}\text{TiO}_{2} + \alpha \text{Re}_{2}\text{O}_{3} + \beta \text{MgO} + \gamma \text{MnO}$ $(\text{Re}_{2}\text{O}_{3} \text{ is at least one or more of the compounds selected}$ from $Y_{2}\text{O}_{3}$, $Gd_{2}\text{O}_{3}$, $Tb_{2}\text{O}_{3}$, $Dy_{2}\text{O}_{3}$, $Ho_{2}\text{O}_{3}$, $Er_{2}\text{O}_{3}$ and $Yb_{2}\text{O}_{3}$, α , β , γ , m and x representing molar ratio in the range of 0.001 \leq $\alpha \leq$ 0.10, 0.001 \leq $\beta \leq$ 0.12, 0.001 < $\gamma \leq$ 0.12, 1.000 < m \leq 1.035 and 0.005 < x \leq 0.22), and containing about 0.2 to 5.0 parts by weight of either a first sub-component or a second sub-component relative to 100 parts by weight of a principal component containing about 0.02% by weight or less of alkali-metal oxides in $(\text{Ba}_{1\text{-x}}\text{Ca}_{7}\text{O})_{m}\text{TiO}_{2}$ as a

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starting material to be used for the dielectric ceramic layer, wherein the first sub-component is a $\rm Li_2O$ -(Si,Ti)O_2-MO based oxide (MO is at least one of the compound selected from $\rm Al_2O_3$ and $\rm ZrO_2$) and the second sub-component is a $\rm SiO_2$ -TiO_2-XO based oxide (XO is at least one of the compound selected from BaO, CaO, SrO, MgO, ZnO and MnO). The inner electrodes are preferably composed of nickel or a nickel alloy.

The material $(Ba_{1-x}Ca_xO)_mTiO_2$ to be used for the dielectric ceramic layer preferably has a mean particle size of about 0.1 to 0.7 μm .

The first sub-component represented by $x \text{LiO}_2-y(\text{Si}_w \text{Ti}_{1-w}) \text{O}_2-z \text{MO}$ (x, y and z are represented by molar percentage (mol%) and w is in the range of 0.30 \leq w \leq 1.0) may be within the area surrounded by the straight lines connecting between the succeeding two points represented by A (x = 20, y = 80, z = 0), B (x = 10, y = 80, z = 10), C (x = 10, y = 70, z = 20), D (x = 35, y = 45, z = 20), E (x = 45, y = 45, z = 10) and F (x = 45, y = 55, z = 0) or on the lines in a ternary composition diagram having apexes represented by each component LiO_2 , $(\text{Si}_w \text{Ti}_{1-w}) \text{O}_2$ and MO provided that when the component is on the line A-F, w is in the range of 0.3 \leq w < 1.0.

The second sub-component represented by $xSiO_2-yTiO_2-zXO$ (x, y and z are represented by mol%) may be within the area surrounded by the straight lines connecting between the succeeding two points represented by A (x = 85, y = 1, z = 14), B (x = 35, y = 51, z = 14), C (x = 30, y = 20, z = 50) and D (x = 39, y = 1, z = 60) or on the lines in a ternary composition diagram having apexes represented by each component SiO_2 , TiO_2 and XO.

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At least one of the compounds $\mathrm{Al}_2\mathrm{O}_3$ and ZrO_2 are contained with a combined amount of about 15 parts by weight (ZrO_2 is about 5 parts by weight or less) in the second sub-component relative to 100 parts by weight of the $\mathrm{SiO}_2\mathrm{-TiO}_2\mathrm{-XO}$ based oxide.

The external electrodes are composed of sintered layers of a conductive metal powder or a conductive metal powder supplemented with a glass frit.

Alternately, the external electrodes are composed of sintered layers of a conductive metal powder or a conductive metal powder supplemented with a glass frit, and plating layers formed thereon.

It is preferable to use the ceramic having the composition to be described hereinafter in order to improve the plating resistance. The dielectric ceramic layer in the laminated ceramic capacitor is represented by the following formula:

 $(\text{Ba}_{1\text{-x}}\text{Ca}_x\text{O})_\text{m}\text{TiO}_2 + \alpha \text{Re}_2\text{O}_3 + \beta \text{MgO} + \gamma \text{MnO}$ (Re $_2\text{O}_3$ is at least one or more of the compounds selected from Y $_2\text{O}_3$, Gd $_2\text{O}_3$, Tb $_2\text{O}_3$, Dy $_2\text{O}_3$, Ho $_2\text{O}_3$, Er $_2\text{O}_3$ and Yb $_2\text{O}_3$, α , β γ , m and x representing molar ratio in the range of 0.001 \leq $\alpha \leq$ 0.10, 0.001 \leq $\beta \leq$ 0.12, 0.001 < $\gamma \leq$ 0.12, 1.000 < m \leq 1.035 and 0.005 < x \leq 0.22), and contains about 0.2 to 5.0 parts by weight of the compound selected from either a first sub-component, a second sub-component or a third sub-component relative to 100 parts by weight of a principal component containing about 0.02% by weight or less of alkali-metal oxides in (Ba $_{1\text{-x}}\text{Ca}_x\text{O}$) mTiO $_2$ as a starting material to be used for the dielectric ceramic layers, wherein the first sub-component is a Li $_2\text{O}$ -B $_2\text{O}_3$ -(Si, Ti)O $_2$ based oxide, the second sub-component is a Al $_2\text{O}_3$ -MO-B $_2\text{O}_3$ based oxide (MO is at least one of the

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compound selected from BaO, CaO, SrO, MgO, ZnO and MnO) and the third sub-component is SiO_2 .

The first sub-component represented by $x \text{LiO}_2 - y \text{B}_2 \text{O}_3 - z \, (\text{Si}_w \text{Ti}_{1-w}) \, \text{O}_2 \, (x, y \text{ and } z \text{ are represented by}$ mol% and w is in the range of 0.30 \leq w \leq 1.0) is preferably within the area surrounded by the straight lines connecting between the succeeding two points represented by A (x = 0, y = 20, z = 80), B (x = 19, y = 1, z = 80), C (x = 49, y = 1, z = 50), D (x = 45, y = 50, z = 5), E (x = 20, y = 75, z = 5) and F (x = 0, y = 80, z = 20) or on the lines in a ternary composition diagram having apexes represented by each component LiO₂, B₂O₃ and (Si_wTi_{1-w})O₂.

At least one of the compounds Al_2O_3 and ZrO_2 are contained in a combined amount of about 20 parts by weight or less (ZrO_2 is about 10 parts by weight or less) in the first sub-component relative to 100 parts by weight of the $Li_2O-B_2O_3-(Si, Ti)O_2$ based oxide.

The second sub-component represented by $xAl_2O_3-yMO-zB_2O_3$ (x, y and z are represented by mol%) is preferably within the area surrounded by the straight lines connecting between the succeeding two points represented by A (x = 1, y = 14, z = 85), B (x = 20, y = 10, z = 70), C (x = 30, y = 20, z = 50), D (x = 40, y = 50, z = 10), E (x = 20, y = 70, z = 10) and F (x = 1, y = 39, z = 60) or on the lines in a ternary composition diagram having apexes represented by each component Al_2O_3 , yMO and zB_2O_3 .

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BRIEF DESCRIPTION OF THE DRAWINGS

Fig. 1 is a cross section showing one example of the laminated ceramic capacitor according to the present invention.

Fig. 2 is a plane view showing the dielectric ceramic layer part having the inner electrodes in the laminated ceramic capacitor shown in FIG. 1.

FIG. 3 is a disassembled perspective view showing the laminated ceramic part in the laminated ceramic capacitor shown in FIG. 1.

FIG. 4 is a ternary composition diagram of the $\text{LiO}_2\text{-}(\text{Si}_w\text{Ti}_{w\text{-}w})\text{O}_2\text{-MO}$ based oxide.

FIG. 5 is a ternary composition diagram of the SiO_2-TiO_2-XO based oxide.

FIG. 6 is a ternary composition diagram of the $\text{Li}_2\text{O}-B_2\text{O}_3-(\text{Si}_w\text{Ti}_{1-w})\,\text{O}_2$ based oxide.

FIG. 7 is a ternary composition diagram of the $Al_2O_3-MO-B_2O_3$ based oxide.

DESCRIPTION OF THE PREFERRED EMBODIMENT

The laminated ceramic capacitor according to the present invention will now be explained in more detail with reference to the accompanying drawings.

Fig. 1 is a cross section showing one example of the laminated ceramic capacitor according to the present invention, Fig. 2 is a plane view showing the dielectric ceramic layer part having the inner electrodes in the laminated ceramic capacitor shown in FIG. 1 and FIG. 3 is a disassembled perspective view showing the laminated ceramic part in the laminated ceramic capacitor shown in FIG. 1. In the laminated ceramic capacitor 1 according to the present invention as shown in FIG. 1, outer electrodes 5, and first plating layers 6 and second

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plating layers 7 if necessary, are formed on both ends of a ceramic laminated body 3 obtained by laminating a plurality of dielectric ceramic layers 2a and 2b via inner electrodes 4.

The dielectric ceramic layers 2a and 2b are composed of a dielectric ceramic composition having as principal components barium calcium titanate $(\mathrm{Ba}_{1\text{-}x}\mathrm{Ca}_{x}\mathrm{O})_{\,\mathrm{m}}\mathrm{TiO}_{2}$, at least one compound selected from $\mathrm{Y}_{2}\mathrm{O}_{3}$, $\label{eq:Gd2O3} \text{Gd}_2\text{O}_3\text{, } \text{Tb}_2\text{O}_3\text{, } \text{Dy}_2\text{O}_3\text{, } \text{Ho}_2\text{O}_3\text{, } \text{Er}_2\text{O}_3\text{ and } \text{Yb}_2\text{O}_3\text{, } \text{MgO and MnO, and } \\$ containing as sub-components either a $\text{Li}_2\text{O-}(\text{Si, Ti})\text{O}_2\text{-MnO}$ based oxide (MO is at least one of the compounds selected from Al_2O_3 and ZrO_2) or a SiO_2 -TiO₂-XO based oxide (XO is at least one of the compounds selected from BaO, CaO, SrO, MgO, ZnO and MnO). The composition described above allows a laminated ceramic capacitor with high reliability and excellent insulating strength to be obtained, wherein the ceramic capacitor can be fired without endowing it with semiconductive properties even by firing in a reducing atmosphere, the temperature characteristics of the electrostatic capacitance satisfy the B-grade characteristics prescribed in the JIS standard and the X7R-grade characteristics prescribed in the EIA standard and the ceramic capacitor has a high insulation resistance at room temperature and at high temperatures.

Also, a highly reliable laminated ceramic capacitor, whose dielectric constant is less affected by variation of electric field even when the dielectric ceramic layers are thinned and magnetic field strength is increased, can be obtained by using a barium calcium titanate material with a mean particle size of about 0.1 to 0.7 μm . The dielectric ceramic assumes a core-shell structure in which Re components (Re is at least one or

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more of the elements selected from Y, Gd, Tb, Dy, Ho, Er and Yb) are distributed in the vicinity of and at grain boundaries by diffusion during firing.

A highly reliable dielectric material can be also obtained by using a barium calcium titanate containing about 0.02% by weight or less of alkali metal oxides such as Na_2O and K_2O .

The ratio (n) of (barium + calcium)/titanium in the barium calcium titanate material is not specifically limited. However, the ratio (n) in the range from about 0.990 to 1.035 is desirable when stability for producing powder materials is taken into consideration.

 ${
m Li}_2{
m O}^-({
m Si},\ {
m Ti}){
m O}_2$ -MO based oxides contained in the principal components described above serve for firing the dielectric ceramics at a relatively low temperature of $1250\,^{\circ}{
m C}$, improving high temperatures load characteristics. ${
m SiO}_2$ -TiO $_2$ -XO based oxides included in the principal components also allow the sintering property to be excellent along with improving the voltage load characteristics at a high temperature and humidity. Further, a higher insulation resistance can be obtained by allowing ${
m Al}_2{
m O}_3$ and ${
m ZrO}_2$ to be contained in the ${
m SiO}_2$ -TiO $_2$ -XO based oxides.

The inner electrode 4 is composed of base metals such as nickel or a nickel alloy.

The outer electrode 5 is composed of a sintered layer of various conductive metals such as Ag, Pd, Ag-Pd, Cu or a Cu alloy, or a sintered layer prepared by blending the foregoing conductive metal powder with various glass fits such as B_2O_3 -Li₂O-SiO₂-BaO based, B_2O_3 -SiO₂-BaO based, Li₂O-SiO₂-BaO based or B_2O_3 -SiO₂-ZnO based glass frit. It is possible to form a plating layer on this sintered layer. Either a first plating layer 6

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comprising Ni, Cu or a Ni-Cu alloy may be merely formed or a second plating layer 7 comprising tin or a solder may be formed on the first plating layer.

The method for producing the laminated ceramic capacitor according to the present invention will be described hereinafter in the order of its production steps with reference to FIGS. 1 to 3.

Powder materials produced by a solid phase method for allowing oxides and carbonates to react at a high temperature or a powder material produced by a wet synthesis method such as a hydrothermal synthesis method or alkoxide method are prepared as starting materials of the dielectric ceramics. A solution of an alkoxide or an organometallic compound may be used for the additives other than oxides and carbonates.

After weighing the prepared materials in a prescribed composition ratio with mixing, the mixed powder is turned into a slurry by adding an organic binder to obtain a green sheet (the dielectric ceramic layers 2a and 2b) by molding the slurry into a sheet. The inner electrodes 4 comprising nickel or a nickel alloy are then formed on one face of the green sheet (the dielectric ceramic layers 2b). Any method including screen printing, vacuum deposition or plating may be used for forming the inner electrodes 4.

Then, a required number of the green sheets (the dielectric ceramic layers 2b) having the inner electrodes 4 are laminated, which are inserted between the green sheets having no inner electrodes (the dielectric ceramic layers 2a) to form a laminated body after pressing. A ceramic laminated body 3 is obtained by firing the laminated body at a given temperature in a reducing atmosphere.

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A pair of the outer electrodes 5 are formed on both side ends of the ceramic laminate body 3 so as to be in electrical continuity with the inner electrodes 4. While the outer electrodes 5 are usually formed by coating the metal powder paste on the ceramic laminated body 3 obtained by firing and baking the paste, the outer electrode may be formed simultaneously with forming the ceramic laminated body 3 by coating the paste prior to firing.

Finally, the first plating layer 6 and the second plating layer 7 are formed, if necessary, on the outer electrodes 5, thereby completing the laminated ceramic capacitor 1.

Examples

15 Example 1

Starting materials TiO_2 , $BaCO_3$ and $CaCO_3$ are at first prepared. After mixing and crushing the materials, the mixture is heated at $1000\,^{\circ}\text{C}$ or more to synthesize nine kinds of barium calcium titanate shown in TABLE 1. The mean particle size was determined by observing the particles of the material under a scanning electron microscope.

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		Table 1		
Kind of Barium Calcium Titanate	(Ba _{1-x} Ca _x O) _n TiO ₂	(Ba+Ca)/Ti	Content of Alkali Metal Oxide Impurities (% by weight)	Mean Particle Size (μm)
A	0.003	1.000	0.003	0.50
В	0.100	1.000	0.010	0.50
С	0.200	0.998	0.012	0.50
D	0.250	0.998	0.015	0.50
Е	0.100	1.000	0.062	0.50
F	0.080	1.005	0.003	0.15
G	0.100	1.008	0.020	0.25
Н	0.100	1.000	0.010	0.75
I	0.100	1.000	0.010	0.08

Oxides, carbonates and hydroxides of respective components of the first sub-component were weighed so as to be a composition (molar) ratio of $0.25 \text{Li}_2\text{O}-0.65 (0.30 \text{TiO}_2 \cdot 0.70 \text{SiO}_2) - 0.10 \text{Al}_2\text{O}_3$ and the mixture was crushed to obtain a powder. Likewise, oxides, carbonates and hydroxides of respective components of the second sub-component were weighed so as to be a composition ratio of $0.66Si_2O-0.17TiO_2-0.15BaO-0.02MnO$ (molar ratio) and the mixture was crushed to obtain a powder. Then, after heating the powders of the first and second sub-components to 1500°C in different crucibles, respectively, they were quenched and crushed to obtain respective oxide powders with a mean particle size of 1 25 μ m or less.

> In the next step, $BaCO_3$ or TiO_2 for adjusting the molar ratio m of (Ba, Ca)/Ti in the barium calcium titanate, and Y_2O_3 , Gd_2O_3 , Tb_2O_3 , Dy_2O_3 , Ho_2O_3 , Er_2O_3 , Yb_2O_3 , MgO and MnO with purity of 99% or more were prepared. These powder materials and the foregoing oxide powders

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for the first and second sub-components were weighed to be the compositions shown in TABLE 2. The amount of addition of the first and second sub-components are given in parts by weight relative to 100 parts by weight of the principal component, i.e., $(\mathrm{Ba_{1-x}Ca_xO})_\mathrm{m}\mathrm{TiO_2} + \alpha\mathrm{Re_2O_3} + \beta\mathrm{MgO} + \gamma\mathrm{MnO}$. A polyvinyl butylal based binder and an organic solvent such as ethanol were added to the weighed materials and the mixture was wet-milled with a ball-mill to prepare a ceramic slurry. This ceramic slurry was formed into a sheet by a doctor blade method, obtaining a rectangular green sheet with a thickness of 4.5 $\mu\mathrm{m}$. Then, a conductive paste mainly containing Ni was printed on the ceramic green sheet to form conductive paste layers constituting the inner electrodes.

E E HUELT "1 E E E E E E E E E E

L						7.7	1ADLE 2							
Sample	Bat-xCax0 m-Ti02+	m.TK		a Re203+	BM	BO+7 MnO	4n0						The First	The Second
Š	Kind of Bartum Calerum	-					В				В	7	Sub-Component (parts by	Sub-Component (parts by
	Titanate	×	Ε	Y203	G420	375203	бу2ОЗН₀2ОЗ	Ho203	Er203	Yb203			weight)	weight)
*	٧	0.003	1.01	0	0	0	0.02	0	0	0	0.02	0.005	-	0
*2	۵	0.250	1.01	0	0	0	0.02	0	0	0	0.02	0.005	-	0
*3	В	0.100	1.01	0	0	0	0.0005	0	0	0	0.02	0.005	-	0
*4	В	0.100	1.01	0	0	0	0.11	0	0	0	0.02	0.005	-	0
*5	В	0.100	1.01	0	0	0	0.02	0	0	0	0.0008	0.005	1	0
9*	В	0.100	1.01	0	0	0	0.02	0	0	0	0.13	0.005	1	0
*7	В	0.100	1.01	0	0	0	0.02	0	0	0	0.02	0.0008	1	0
*	В	0.100	1.01	0	0	0	0.02	0	0	0	0.02	0.13	ļ	0
6*	В	0.100	0.995	0	0	0	0.02	0	0	0	0.02	0.005	1	0
*10	В	0.100	-	0	0	0	0.02	0	0	0	0.02	0.005	1	0
*11	В	0.100	1.036	0	0	0	0.02	0	0	0	0.02	0.005	1	0
*12	В	0.100	1.01	0	0	0	0.02	0	0	0	0.02	0.005	0	0
*13	8	0.100	1.01	0	٥	0	0.02	0	0	0	0.02	0.1	0	0
*14	8	0.100	1.01	0	0	0	0.02	0	0	0	0.02	0.005	5.5	0
*15		0.100	1.01	0	0	0	0.02	0	0	0	0.02	0.005	0	5,5
*16	Е	0.100	1.01	0	0	0	0.02	0	0	0	0.02	0.005	1	0
17	I	0.100	1.01	0	0	0	0.02	0	0	0	0.02	0.005	1	0
18	-	0.100	1.01	0	0	0	0.02	0	0	0	0.02	0.005	-	0
19	O	0.100	1.025	0.025	0	0	0	0	0	0	0.02	0.005	0	
20	O	0.100	1.02	0	0.08	0	0	0	0	0	0.05	0.008	4	0
21	O	0.100	1.015	0	0	0.05	0	0	0	0	0.05	0.005	3	0
22	В	0.100	10.	0	0	0	0	0.02		0	0.02	0.05	2	0
23	. 8	0.100	1.01	0	0	0	0	0	0.02	0	0.02	0.05	0	
24	O	0.200	1.005	0	0	0	0	0	0	0.03	0.02	0.05	0	-
25	O	0.200	1.005	0.005	0	0	0.02	0	0	0	0.02	0.005	0	-
26			1.015	0.005	0.015	0	0	0	0	0	0.02	0.005	2	0
27	Ħ.	0.080	1.015	0	0	0	0.02		0	0	0.02	0.005	0	2

* The samples marked (*) are out of the range of the present invention.

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Next, a plurality of ceramic green sheets on which the conductive paste layers had been formed were laminated to obtain a laminated body so that the sides where the conductive paste layers are exposed alternately come to the opposite ends. The laminated body was heated at a temperature of 350°C in a N_2 atmosphere. After driving out the binder, the laminated body was fired in a reducing atmosphere comprising a $H_2-N_2-H_2O$ gas with an oxygen partial pressure of 10^{-9} to 10^{-12} MPa to obtain a ceramic sintered body.

After firing, an Ag paste containing a $B_2O_3\text{-Li}_2\text{-SiO}_2\text{-BaO}$ based glass frit was coated on both side faces of the ceramic sintered body, which was baked at a temperature of 600°C in the N_2 atmosphere to form the outer electrodes electrically connected to the inner electrodes.

The laminated ceramic capacitor thus obtained had an overall dimension with a width of 5.0 mm, a length of 5.7 mm and a thickness of 2.4 mm with a thickness of the dielectric ceramic layers inserted between the inner electrodes of 3 μ m. The total number of the effective dielectric ceramic layers was five with a confronting electrode area per layer of 16.3 \times 10⁻⁶ m².

Electric characteristics of these laminated ceramic capacitors were then determined. Electrostatic capacitances and dielectric losses (tan δ) were measured per JIS C5102 standard using an automatic bridge type measuring apparatus and dielectric constant was calculated from the electrostatic capacitance obtained. Insulation resistance was also measured using an insulation resistance meter by impressing a direct-current voltage of 10 V for 2 minutes to calculate resistivity (ρ) .

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DV vias characteristics were also measured. The electrostatic capacitance was determined while impressing a direct-current voltage of 15 V (5 kV/mm) and the rate of change of the electrostatic capacitance (Δ C %) was determined relative to the electrostatic capacitance measured without impressing a direct-current voltage.

The rate of temperature dependent change of the electrostatic capacitance was also measured. The maximum value of the rate of change in the temperature range from -25°C to 85°C relative to the capacitance at 20°C (Δ C/C20) and the maximum value of the rate of change in the temperature range from -55°C to 125°C relative to the capacitance at 25°C (Δ C/C25) were determined with respect to the rate of change of the capacitance.

A high temperature load test was carried out by measuring the time dependent changes of the insulation resistance when a direct-current voltage of 30 V was impressed at 150°C. Lifetime of each sample was defined to be the time when the insulation resistance of each sample had decreased to $10^5~\Omega$ or less, and a mean lifetime was determined using a plurality of the samples.

The dielectric breakdown voltage was measured by impressing DC voltages with a voltage increasing rate of 100 V/sec. The results are summarized in TABLE 3.

Name						TABLE 3				
Trap (Total Invasion Inv		Burning). And and a second	Rate of Change of Capacitance	Rate of Temperate Change of Co	ure Dependent apacitance	Resistivity	Dielectric Breakdowp Voltage	Mean
(°C) tan δ DC -25~+85°C -55~+125°C (Ω·cm) (⟨V/cm) 1300 3360 4.5 -65 -9.7 -156 13.2 1 1300 3360 4.5 -65 -9.7 -156 13.2 1 1250 1130 9.3 -35 -4.5 -1.5 13.2 1 1250 2430 4.6 -55 -1.5 -10.6 13.2 1 1250 2720 3.6 -6.3 -1.5 -2.4 12.9 1 1250 1780 4.4 -6.3 -1.5 -1.4 13.1 1 1250 1780 4.4 -6.3 -1.2 -1.4 11.2 1 1250 1780 4.4 -6.5 -1.2 -1.4 11.2 1 1250 1780 4.4 -5.0 -1.2 -1.4 11.2 1 1250 180 4.4 -5.0 -6.2 -1.2.5 <th>mple</th> <th>Temp</th> <th>Dielectric Constant</th> <th>Loss</th> <th>VCX</th> <th>Ο O</th> <th>/C25</th> <th></th> <th>DC</th> <th>Lıfetime</th>	mple	Temp	Dielectric Constant	Loss	VCX	Ο O	/C25		DC	Lıfetime
1300 564) 5Kv/mm (96) (96) 1300 3360 4.5 -65 -9.7 -15.6 13.2 1250 1130 9.3 -35 -4.5 -6.5 13.1 1250 2430 4.6 -5.5 -1.5 -10.6 13.2 1250 1220 3.1 -37 -18.1 -23.3 13.5 1250 1250 3.6 -6.3 -1.5 -10.6 13.2 1250 1260 4.4 -4.5 -7.8 -14.6 13.1 1250 1760 4.7 -5.7 -9.6 -15.4 11.8 1250 170 3.8 -5.6 -10.5 -14.6 11.2 1250 170 3.8 -5.6 -12.3 -14.6 11.2 1250 170 3.4 -5.7 -9.6 -12.4 11.8 1250 170 4.4 -5.0 -12.3 -14.6 11.2	}	වු		tan ð	2	-25~+85°C	~+12	(Q • cm)	(kV/mm)	(F)
1300 3360 4.5 -65 -9.7 -15.6 13.2 1250 1130 9.3 -35 -4.5 -6.5 13.1 1250 2430 4.6 -55 -1.5 -10.6 13.2 1250 1220 3.1 -37 -18.1 -23.3 13.5 1250 1270 3.6 -63 -15.6 -24.7 12.9 1250 1780 4.4 -45 -7.8 -14.6 13.1 1250 1730 3.8 -56 -13.6 -14.7 11.8 1250 1730 3.8 -56 -13.6 -14.4 11.2 1250 1730 3.8 -56 -12.2 -14.4 11.2 1250 1750 3.2 -62 -12.2 -14.4 12.3 1250 170 3.4 -50 -12.2 -14.4 12.3 1250 170 3.4 -50 -12.2 -14.4	I			(%)	5Kv/mm	(%)	(%)			
1250 1130 9.3 -35 -45 -6.5 13.1 1250 2430 4.6 -55 -1.5 -10.6 13.2 1250 1220 3.1 -37 -18.1 -23.3 13.5 1250 1220 3.6 -63 -15.6 -24.7 12.9 1250 1780 4.4 -45 -7.8 -14.6 13.1 1250 1780 4.7 -57 -9.6 -15.4 11.8 1250 1730 3.8 -56 -13.6 -14.4 11.8 1250 2100 5.6 -60 -12.3 -18.6 11.2 1250 1750 3.2 -62 -12.2 -14.4 12.3 1260 1530 4.4 -50 -8.6 -14.4 12.3 1200 1580 3.7 -48 -10.5 -14.4 13.1 1250 1750 3.7 -8.9 -14.2 13.2 <th>-</th> <th>1300</th> <th>3380</th> <th>4.5</th> <th>-65</th> <th>7.6-</th> <th>-15.6</th> <th>13.2</th> <th>14</th> <th>3</th>	-	1300	3380	4.5	-65	7.6-	-15.6	13.2	14	3
1250 2430 4.6 -55 -1.5 -10.6 13.2 1250 1220 3.1 -37 -18.1 -23.3 13.5 1250 1270 3.6 -63 -15.6 -24.7 12.9 1250 1780 44 -45 -7.8 -14.6 13.1 1250 1780 47 -57 -9.6 -15.4 11.8 1250 1730 38 -56 -13.6 -19.7 11.2 1250 1730 5.3 -62 -12.2 -19.7 11.2 1250 1750 5.3 -62 -12.2 -17.5 11.2 1300 1850 4.4 -50 -12.2 -17.5 11.6 1300 1850 4.4 -50 -18.6 -14.4 12.3 1250 1750 4.4 -50 -18.6 -14.4 12.3 1250 1760 3.2 -4.8 -14.5 -14.7	2	1250	1130	9.3	-35	-4.5	-6.5	13.1	15	23
1250 121 -37 -181 -23.3 135 1250 2570 3.6 -63 -15.6 -24.7 12.8 1350 1780 4.4 -45 -7.8 -14.6 13.1 1250 1780 4.7 -57 -9.6 -15.4 11.8 1250 1730 3.8 -56 -6.0 -12.3 -18.6 11.2 1250 2100 5.6 -6.0 -12.3 -18.6 11.2 1250 2060 5.3 -6.2 -12.2 -17.5 11.6 1350 1850 4.4 -5.0 -8.6 -14.4 12.3 1350 1470 5.3 -4.5 -8.9 -14.2 11.6 1200 1860 3.2 -4.8 -14.5 13.1 11.4 1200 1800 3.7 -4.8 -10.5 -14.4 13.1 1250 170 3.7 -4.8 -10.5 -15.1	6	1250	2430	4.6	-55	-1.5	-10.8	13.2	14	7
1250 2570 3.6 -63 -15.6 -24.7 12.8 1350 1780 44 -45 -7.8 -14.6 131 1250 1780 47 -57 -9.6 -15.4 11.8 1250 1730 3.8 -56 -60 -12.3 -18.6 11.2 1250 2100 5.6 -60 -12.2 -17.5 11.2 1250 2100 5.3 -62 -12.2 -17.5 11.6 1300 1850 4.4 -50 -8.6 -14.4 12.3 1300 1850 5.1 -45 -8.9 -14.4 12.3 1250 1470 5.3 -48 -14.5 -30.6 13.1 1250 1750 3.7 -48 -10.5 -14.4 13.1 1250 1750 3.7 -48 -10.5 -14.4 13.2 1150 1040 2.5 -30.6 13.4	4	1250	1220	3.1	-37	-18.1	-23.3	13.5	15	15
1350 1780 4.4 -45 -78 -14.6 131 1250 1950 4.7 -57 -96 -15.4 11.8 1250 1730 3.8 -56 -13.6 -19.7 11.2 1250 2100 5.6 -60 -12.3 -18.6 11.2 1250 2100 5.3 -62 -12.2 -17.5 11.2 1300 1850 4.4 -50 -8.6 -14.4 12.3 1300 1850 4.4 -50 -8.8 -14.4 12.3 1300 1850 4.4 -50 -8.8 -14.2 11.4 1200 1740 3.4 -4.2 -13.3 -26.8 13.1 1200 1740 3.4 -4.2 -14.5 13.1 13.1 1250 1750 3.7 -4.8 -10.5 -14.2 13.1 1150 1040 2.5 -30 -8.4 -14.2	5	1250	2570	3.6	-63	-15.6	-24.7	12.9	12	65
1250 1950 4.7 -57 -9.6 -15.4 11.8 1250 1730 3.8 -56 -13.6 -19.7 11.2 1250 2100 5.6 -60 -12.3 -18.6 11.2 1250 2060 5.3 -62 -12.2 -17.5 11.6 1300 1850 4.4 -50 -8.6 -14.4 12.3 1350 150 5.3 -47 -8.9 -14.2 11.4 1350 1470 5.3 -48 -14.2 13.1 1200 1680 3.2 -48 -14.2 13.1 1200 1740 3.4 -42 -13.6 13.1 1200 1750 3.7 -48 -14.5 -30.6 13.1 1250 230 4.7 -51 -4.7 -6.7 13.1 1150 140 2.5 -30.6 -14.4 13.2 1150 2.1 -3	8	1350	1780	4.4	-45	-7.8	-14.6	13.1	14	2
1250 1730 38 -56 -136 -197 11.2 1250 2100 5.6 -60 -12.3 -18.6 11.2 1250 2060 5.3 -62 -12.2 -17.5 11.6 1300 1850 4.4 -50 -8.6 -14.4 12.3 1350 1850 5.1 -45 -8.9 -14.2 11.4 1350 1470 5.3 -48 -14.5 -14.2 11.4 1200 1740 3.4 -42 -18.9 -14.2 11.5 1200 1740 3.4 -42 -13.3 -26.8 13.1 1250 1750 3.7 -48 -10.5 -15.1 13.1 1250 1750 3.7 -48 -10.5 -14.2 13.1 1150 170 2.5 -30 -8.4 -14.4 13.2 1150 1260 2.3 -35 -9.6 -13.4	7	1250	1950	4.7	-57	9.6	-15.4	11.8	14	11
1250 2100 5.6 -60 -12.3 -18.6 11.2 1250 2060 5.3 -62 -12.2 -17.5 11.6 1300 1850 4.4 -50 -8.6 -14.4 12.3 1350 1850 5.1 -45 -8.6 -14.4 12.3 1350 150 5.3 -47 -8.9 -14.2 11.4 1350 1470 5.3 -48 -14.5 -30.6 13.1 1200 1740 3.4 -42 -13.3 -28.8 13.1 1250 1750 3.7 -48 -10.5 -15.1 13.1 1250 1750 3.7 -48 -10.5 -14.2 13.1 1150 1040 2.5 -30 -8.4 -14.2 13.1 1150 1260 2.3 -36 -9.6 -14.4 13.2 1150 1260 2.3 -36 -9.6 -14.6	8	1250	1730	3.8	56	-13.6	-19.7	11.2	14	8
1250 2060 5.3 -62 -12.2 -17.5 11.6 1300 1850 4.4 -50 -8.6 -14.4 12.3 1350 150 5.1 -45 -8.6 -14.2 11.4 1350 150 5.3 -47 -8.9 -14.2 11.5 1200 1470 5.3 -48 -14.5 -26.8 13.1 1200 1740 3.4 -42 -13.3 -26.8 13.1 1250 1750 3.7 -48 -10.5 -15.1 13.1 1250 1750 3.7 -48 -16.7 13.1 13.1 1150 1040 2.5 -30 -8.4 -14.4 13.2 1150 1260 2.3 -36 -9.6 -14.4 13.2 1175 1260 2.3 -36 -9.6 -14.4 13.2 1250 1260 2.3 -36 -9.6 -13.4 <t< td=""><td>6</td><td>1250</td><td>2100</td><td>5.6</td><td>-60</td><td>-12.3</td><td>18.6</td><td>11.2</td><td>8</td><td>1</td></t<>	6	1250	2100	5.6	-60	-12.3	18.6	11.2	8	1
1300 1850 4.4 -50 -8.6 -14.4 12.3 1350 1530 5.1 -45 -8.6 -13.7 11.4 1350 1470 5.3 -47 -8.9 -14.2 11.5 1200 170 3.2 -48 -14.5 -30.6 13.1 1200 1740 3.4 -42 -13.3 -26.8 13.1 1250 1750 3.7 -48 -10.5 -15.1 13.1 1250 2370 4.7 -51 -4.7 -6.7 13.1 1150 1260 2.5 -30 -8.4 -14.4 13.2 1175 1260 2.3 -36 -9.6 -14.4 13.2 1175 1260 2.3 -36 -9.6 -14.6 13.2 1270 130 2.1 -4.7 -8.6 -13.4 13.2 1270 2.2 -3.2 -3.6 -9.6 -14.6 <t< td=""><td>0</td><td>1250</td><td>2060</td><td>5.3</td><td>-62</td><td>-12.2</td><td>-17.5</td><td>11.6</td><td>6</td><td>1</td></t<>	0	1250	2060	5.3	-62	-12.2	-17.5	11.6	6	1
1350 1530 51 -45 -88 -13.7 11.4 1350 1470 5.3 -47 -8.9 -14.2 11.5 1200 1680 3.2 -48 -14.5 -30.6 13.1 1200 1740 3.4 -42 -13.3 -26.8 13.1 1250 1750 3.7 -48 -10.5 -15.1 13.1 1250 2370 4.7 -51 -4.7 -6.7 13.1 1150 1040 2.5 -30 -8.4 -14.2 13.5 1150 1260 2.2 -35 -9.6 -14.4 13.2 1175 1260 2.3 -36 -9.2 -14.6 13.2 1270 1900 2.1 -42 -8.6 -13.4 13.2 1250 1900 2.1 -42 -8.6 -13.4 13.1 1250 1430 1.8 -3.4 -7.8 -11.4 <td< td=""><td>-</td><td>1300</td><td>1950</td><td>4.4</td><td>-50</td><td>9.8-</td><td>-14.4</td><td>12.3</td><td>6</td><td>-</td></td<>	-	1300	1950	4.4	-50	9.8-	-14.4	12.3	6	-
1350 1470 5.3 -47 -8.9 -14.2 11.5 1200 1680 3.2 -48 -14.5 -26.8 13.1 1200 1740 3.4 -42 -13.3 -26.8 13.1 1250 1750 3.7 -48 -10.5 -15.1 13.1 1250 2370 4.7 -51 -4.7 -6.7 13.1 1150 1040 2.5 -30 -8.4 -14.2 13.5 1150 1260 2.3 -33 -8.8 -14.4 13.2 1150 1260 2.3 -36 -9.6 -14.4 13.2 1270 1900 2.1 -42 -8.6 -13.4 13.2 1250 1430 1.8 -34 -8.6 -13.4 13.1 1250 1450 1.8 -34 -7.8 -11.4 13.1 1250 1450 1.9 -3.1 -8.5 -11.4 <	2	1350	1530	5.1	-45	-8.8	-13.7	11.4	10	1
1200 1680 3.2 -48 -14.5 -30.6 13.1 1200 1740 3.4 -42 -13.3 -26.8 13.1 1250 1750 3.7 -48 -10.5 -15.1 13.1 1250 2370 4.7 -51 -4.7 -6.7 13.1 1150 1040 2.5 -30 -8.4 -14.2 13.2 1150 1260 2.2 -35 -9.6 -14.4 13.2 1150 1260 2.3 -3.6 -9.6 -14.4 13.2 1200 1260 2.3 -3.6 -9.6 -14.4 13.2 1200 1900 2.1 -42 -8.6 -13.4 13.2 1250 2010 2.5 -44 -8.5 -13.4 13.1 1250 1450 1.8 -3.4 -7.8 -11.4 13.1 1250 1450 1.9 -3.1 -8.2 -11.4	3	1350	1470	5.3	-47	-8.9	-14.2	11.5	6	1
1200 1740 3.4 -42 -13.3 -26.8 13.1 1250 1750 3.7 -48 -10.5 -15.1 13.1 1250 2370 4.7 -51 -4.7 -6.7 13.1 1150 1040 2.5 -30 -8.4 -14.2 13.5 1175 1410 2.2 -35 -9.6 -14.4 13.2 1175 1260 2.3 -36 -9.2 -14.6 13.2 1200 1900 2.1 -42 -8.6 -13.4 13.2 1250 1430 1.8 -34 -8.5 -13.4 13.1 1250 1450 1.9 -31 -8.5 -11.4 13.1 1250 1450 1.9 -31 -8.5 -11.4 13.1 1175 1260 1.7 -32 -9.5 -11.4 13.1 1175 1340 1.6 -3.3 -9.5 -11.1 <t< td=""><td>4</td><td>1200</td><td>1680</td><td>3.2</td><td>-48</td><td>-14.5</td><td>-30.6</td><td>13.1</td><td>14</td><td>5</td></t<>	4	1200	1680	3.2	-48	-14.5	-30.6	13.1	14	5
1250 1750 3.7 -48 -10.5 -15.1 13.1 1250 2370 4.7 -51 -4.7 -6.7 13.1 1150 1040 2.5 -30 -8.4 -14.2 13.5 1150 1040 2.2 -35 -9.6 -14.4 13.2 1150 1260 2.3 -36 -9.2 -14.6 13.2 1200 1900 2.1 -42 -8.6 -13.4 13.2 1250 2010 2.5 -44 -8.5 -13.4 13.2 1250 1430 1.8 -34 -7.8 -11.4 13.1 1250 1450 1.9 -31 -8.2 -11.4 13.1 1175 1260 1.7 -32 -9.5 -14.5 13.2 1175 1340 1.6 -33 -9.2 -11.5 13.2 1175 1350 13.3 -9.5 -14.5 13.2	5	1200	1740	3.4	-42	-13.3	-26.8	13.1	14	က
1250 2370 4.7 -51 -4.7 -6.7 13.1 1150 1040 2.5 -30 -8.4 -14.2 13.5 1175 1410 2.2 -35 -9.6 -14.4 13.2 1150 1260 2.3 -33 -8.8 -14.6 13.2 1270 1260 2.3 -36 -9.2 -14.6 13.2 1250 1900 2.1 -42 -8.6 -13.4 13.2 1250 1430 1.8 -34 -7.8 -11.4 13.1 1250 1450 1.9 -31 -8.2 -11.4 13.1 1175 1260 1.7 -32 -9.2 -14.5 13.2 1175 1340 1.6 -33 -9.2 -13.5 13.2	9	1250	1750	3.7	-48	-10.5	-15.1	13.1	14	21
1150 1040 2.5 -30 -8.4 -14.2 13.5 1175 1410 2.2 -35 -9.6 -14.4 13.2 1150 1260 2.3 -36 -9.6 -13.7 13.2 1200 1260 2.3 -36 -9.2 -14.6 13.2 1200 1900 2.1 -42 -8.6 -13.4 13.2 1250 2010 2.5 -44 -8.5 -13.8 13.2 1250 1450 1.8 -34 -7.8 -11.4 13.1 1175 1260 1.7 -32 -9.5 -11.5 13.2 1175 1340 1.6 -33 -9.2 -13.5 13.2		1250	2370	4.7	-51	-4.7	-6.7	13.1	13	52
1175 1410 2.2 -35 -9.6 -14.4 13.2 1150 1260 2.3 -36 -9.2 -14.6 13.2 1175 1260 2.3 -36 -9.2 -14.6 13.2 1200 1900 2.1 -42 -8.6 -13.4 13.2 1250 1430 1.8 -34 -7.8 -11.4 13.1 1250 1450 1.9 -31 -8.2 -11.4 13.2 1175 1260 1.7 -32 -9.5 -14.5 13.2 1175 1340 1.6 -33 -9.2 -13.5 13.2		1150	1040	2.5	-30	-8.4	-14.2	13.5	15	174
1150 1260 2.3 -8.8 -13.7 13.2 1175 1260 2.3 -36 -9.2 -14.6 13.2 1200 1900 2.1 -42 -8.6 -13.4 13.2 1250 2010 2.5 -44 -8.5 -13.8 13.2 1250 1430 1.8 -34 -7.8 -11.4 13.1 1175 1260 1.7 -32 -9.5 -14.5 13.2 1175 1340 1.6 -33 -9.2 -13.5 13.2		1175	1410	2.2	-35	-9.6	-14.4	13.2		85
1175 1260 2.3 -36 -9.2 -14.6 13.2 1200 1900 2.1 -42 -8.6 -13.4 13.2 1250 2010 2.5 -44 -8.5 -13.8 13.2 1250 1430 1.8 -34 -7.8 -11.4 13.1 1250 1450 1.9 -31 -8.2 -11.1 13.2 1175 1260 1.7 -32 -9.5 -14.5 13.2 1175 1340 1.6 -33 -9.2 -13.5 13.2		1.150	1260	2.3	-33	-8.8	-13.7	13.2	15	110
1200 1900 2.1 -42 -8.6 -13.4 13.2 1 1250 2010 2.5 -44 -8.5 -13.8 13.2 1 1250 1430 1.8 -34 -7.8 -11.4 13.1 1 1250 1450 1.9 -31 -8.2 -11.1 13.2 1 1175 1260 1.7 -32 -9.5 -14.5 13.2 1 1175 1340 1.6 -33 -9.2 -13.5 13.2 1		1175	1260	2.3	-36	-9.2	-14.6	13.2	14	105
1250 2010 2.5 -44 -8.5 -13.8 13.2 1 1250 1430 1.8 -34 -7.8 -11.4 13.1 1 1250 1450 1.9 -31 -8.2 -11.1 13.2 1 1175 1260 1.7 -32 -9.5 -14.5 13.2 1 1175 1340 1.6 -33 -9.2 -13.5 13.2 1	<u> </u>	1200	1900	2.1	-42	-8.6	-13.4	13.2	14	85
1250 1430 1.8 -34 -7.8 -11.4 13.1 1 1250 1450 1.9 -31 -8.2 -11.1 13.2 1 1175 1260 1.7 -32 -9.5 -14.5 13.2 1 1175 1340 1.6 -33 -9.2 -13.5 1	_	1250	2010	2.5	-44	-8.5	-13.8	13.2	15	80
1250 1450 1.9 -31 -8.2 -11.1 13.2 1 1175 1260 1.7 -32 -9.5 -14.5 13.2 1 1175 1340 1.6 -33 -9.2 -13.5 13.2 1		1250	1430	1.8	-34	-7.8	-11.4	13.1	14	110
1175 1260 1.7 -32 -9.5 -14.5 13.2 1 1175 1340 1.6 -33 -9.2 -13.5 13.2 1		1250	1450	1.9	-31	-8.2	-11.1	13.2	15	120
1175 1340 1.6 -33 -9.2 -13.5 13.2 1		1175	1260		-32	-9.5	-14.5	13.2	14	92
		1175	1340	1.6	-33	-9.2	-13.5	13.2	14	95

^{*} The samples marked by (*) are out of the range of the present invention.

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The cross section of the laminated ceramic capacitor obtained was polished and subjected to chemical etching. It was found from scanning electron microscopic observation of the grain size in the dielectric ceramics that the grain size was almost equal to the particle size of the barium calcium titanate starting material in the samples having the compositions within the range of the present invention.

As are evident from TABLE 1 to TABLE 3, the rate of temperature dependent change of the electrostatic capacitance satisfies the B-grade characteristic standard prescribed in the JIS standard in the temperature range from -25°C to +85°C, along with satisfying the X7R-grade characteristic standard prescribed in the EIA standard in the temperature range from -55°C to +125°C, in the laminated ceramic capacitor according to the present invention. In addition, the rate of change of the capacitance when a DC voltage of 5 kV/mm is impressed is as small as within 51%, the change of the electrostatic capacitance being also small when the capacitor is used has thin layers. Moreover, the mean lifetime in the high temperature load test is as long as 52 hours or more, enabling one to fire at a firing temperature of 1250°C or below.

The reason why the compositions are limited in the present invention will be described hereinafter.

In the composition represented by the following formula:

 $(\text{Ba}_{1\text{-x}}\text{Ca}_{x}\text{O})_{m}\text{TiO}_{2} + \alpha \text{Re}_{2}\text{O}_{3} + \beta \text{MgO} + \gamma \text{MnO}$ $(\text{Re}_{2}\text{O}_{3} \text{ represents at least one of the compounds selected}$ $\text{from } Y_{2}\text{O}_{3}, \text{ Gd}_{2}\text{O}_{3}, \text{ Tb}_{2}\text{O}_{3}, \text{ Dy}_{2}\text{O}_{3}, \text{ Ho}_{2}\text{O}_{3}, \text{ Er}_{2}\text{O}_{3} \text{ and } \text{Yb}_{2}\text{O}_{3} \text{ and } \alpha, \beta$ and γ represent molar ratios), a CaO content (x) of about 0.005 or less as in the sample No. 1 is not preferable

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since the rate of impressed voltage dependent change of the capacitance becomes large and the mean lifetime becomes extremely short. It is also not preferable that the CaO content (x) exceeds about 0.22 as in the sample No. 2 because the dielectric loss is increased. Accordingly, the preferable CaO content (x) is in the range of 0.005 $< x \le 0.22$.

A $\mathrm{Re_2O_3}$ content (α) of less than about 0.001 as in the sample No. 3 is also not preferable because the mean lifetime becomes extremely short. It is also not preferable that the content of $\mathrm{Re_2O_3}$ (α) exceed about 0.10 since the temperature characteristics do not satisfy the B/X7R-grade characteristics while the mean lifetime is shortened. Accordingly, the preferable $\mathrm{Re_2O_3}$ content (α) is in the range of 0.001 $\leq \alpha \leq$ 0.10.

A MgO content (β) of less than about 0.001 as in the sample No. 5 is also not preferable because the rate of impressed voltage dependent change of the capacitance becomes large while the temperature characteristics do not satisfy the B/X7R-grade characteristics. It is also not preferable that the amount of addition (β) of MgO exceed about 0.12 as in the sample No. 6 since the sintering temperature becomes high to extremely shorten the mean lifetime. Accordingly, the preferable MgO content (β) is in the range of 0.001 $\leq \beta \leq$ 0.12.

A MnO content (γ) of less than about 0.001 as in the sample No. 7 is also not preferable because the capacitance is lowered while the mean lifetime is shortened. It is also not preferable that the MnO content (γ) exceed about 0.12 as in the sample No. 8 since the temperature characteristics do not satisfy the B/X7R-grade characteristics, the resistivity becomes low

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and the mean lifetime is shortened. Accordingly, the preferable range of the MnO content (γ) is 0.001 < γ \leq 0.12.

It is not preferable that the ratio (m) of (Ba, Ca)/Ti is less than about 1.000 as in the samples No. 9 and No. 10 because the temperature characteristics do not satisfy the B/X7R-grade characteristics, thereby lowering the resistivity besides immediately causing short circuit troubles when a voltage is impressed in the high temperature load test. It is also not preferable that the ratio (m) of (Ba, Ca)/Ti exceed about 1.035 as in the sample No. 11 because sintering is insufficient to extremely shorten the mean lifetime. Accordingly, the preferable ratio (m) of (Ba, Ca)/Ti is in the range of $1.000 < m \le 1.035$.

It is not preferable that the contents of the first and second sub-components are zero as in the samples No. 12 and No. 13 because the resistivity is lowered to immediately cause short circuit troubles when a voltage is impressed in the high temperature load test. It is also not preferable that the contents of the first and second sub-components exceed about 5.0 parts by weight as in the sample Nos. 14 and 15 because the second phase based on glass components is increased and the temperature characteristics do not satisfy the B/X7R-grade characteristics and the mean lifetime is extremely shortened. Accordingly, the preferable content of either the first component or the second component is in the range of about 0.2 to 5.0 parts by weight.

The content of the alkali metal oxides contained in barium calcium titanate as impurities is adjusted to about 0.02% by weight or less because, when the content of the alkali metal oxides exceeds about

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0.02% by weight as in the sample No. 16, the mean lifetime is shortened.

The sample No. 17 in which the mean particle size of barium calcium titanate exceeds 0.7 μm shows a little poor mean lifetime of 52 hours. The sample No. 18 in which the mean particle size of barium calcium titanate is less than 0.1 μm shows, on the other hand, a little small dielectric constant of 1040. Accordingly, the preferable mean particle size of barium calcium titanate is in the range from about 0.1 to 0.7 μm .

Example 2

A dielectric powder material represented by the following formula was prepared using the barium calcium titanate (B) in TABLE 1:

 $(Ba_{0.90}Ca_{0.10}O)_{1.010} \cdot TiO_2 + 0.02Dy_2O_3 + 0.02MgO + 0.010MnO (molar ratio)$

A laminated ceramic capacitor was produced by the same method as used in Example 1, except that a $\text{Li}_2\text{O-}(\text{Si},\text{Ti})\,\text{O}_2\text{-MO}$ based oxide as the first sub-component having a mean particle size of 1 μm listed in TABLE 4 was added to the mixture above. The size and shape of the laminated ceramic capacitor produced in this example were the same as those in Example 1. The electric characteristic were measured by the same method as used in Example 1. The results are shown in TABLE 5.

			TABLE 4			
			First Subco	mponent		
Sample. No.	Amount of addition		Compositi	ion (mol%, e	xcept w)	···
110.	(parts by weight)	Li ₂ O	(Si _w Ti _{1-w})	w	Al ₂ O ₃	ZrO ₂
101	1	20	80	0.3	0	0
102	1	10	80	0.6	5	5
103	1	10	70	0.5	20	0
104	2	35	45	1	10	10
105	2	45	3 5	0.5	10	0
106	2	45	55	0.3	0	0
107	1.5	20	70	0.6	5	5
108	1.5	20	70	0.4	10	0
109	2	30	60	0.7	5	5
110	2	30	60	0.8	10	0
111	2	40	50	0.6	5	5
112	2	40	50	0.9	\$	10
113	2	10	85	0.4	5	0
114	2	5	75	0.6	10	10
115	3	20	55	0.5	25	0
116	3	45	40	0.8	0	15
117	3	50	45	0.7	5	0
118	2	25	75	0.9	0	0
119	2	25	75	1	0	0
120	2	45	65	0.9	0	0
121	2	35	65	1	0	0
122	1	20	70	0.2	0	10

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TABLE	
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	Dielectrie Breakdown Voltage Mean	DC	(kV/mm) (h)	Т	14 82	15 86		15 88	14 90	14 80	14 85		14 90	14 95	15 91	14 87	6	8	8	8	8	15 88	6	14 88	8	ď
	Resistivity	d Moj	(mɔ•℧)		13.2	13.1	13.2	13.5	13.2	13.1	13.3	13.2	13.3	13.2	13.2	13.3	11.5	10.8	10.6	10.8	11.2	13.2	11.1	13.2	10.2	102
	iture Dependent Japacitance	Δ C/C25 %	-55~+125°C	(%)	-12.8	-12.6	-12.3	-12.5	-11.7	-12.0	-12.1	-11.8	-11.7	-12.1	-12.1	-11,8	-12.2	-12.6	-12.5	-12.2	-12.4	-11.7	-11.6	-11.7	-12.8	-115
TABLE 5	Rate of Lemperature Dependent Change of Capacitance	∆ C/C20 %	_25~+85℃	(%)	-8.2	-7.8	7.7-	-7.5	-7.2	-7.8	-8.1	-7.8	7.7-	-7.9	-7.8	-7.6	-7.9	-8.0	-7.8	-7.8	-8.6	-7.8	-8.2	-7.6	-8.5	-82
	Rate of Change of Capacitance	AC %	2	5Kv/mm	43	-42	-41	-41	-42	-40	-42	-42	-41	-42	-42	-40	-42	-41	-42	-43	43	-43	-40	-42	-44	-44
	Dielectric	Loss	tan ô	(%)	2.4	2.4	2.5	2.4	2.4	2.4	2.4	2.3	2.5	2.5	2.4	2.3	2.2	2.4	2.6	2.8	2.4	2.3	2.1	2.5	2.1	2.1
		Dielectric Constant			1920	1910	1870	1850	1870	1870	1910	1910	1890	1900	1890	1850	1620	1460	1330	1420	1360	1920	1450	1900	1350	1420
	Burinng	Тепр	၌		1250	1250	1250	1225	1225	1225	1250	1250	1225	1225	1225	1225	1300	1300	1300	1300	1300	1250	1300	1250	1300	1350
		No			101	102	103	104	105	106	107	108	109	110	Ξ	112	113	114	115	116	117	118	119	120	121	122

- : Measurement is Impossible

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As are evident from Table 4 and Table 5, the sample Nos. 101 to 112, 118 and 120, in which $\mathrm{Li_2O}\text{-}(\mathrm{Si_wTi_{1-w}})\,\mathrm{O_2}\text{-Mo}$ based oxides with compositions within the area surrounded by the straight lines connecting between the succeeding two points represented by A (x =20, y = 80, z = 0), B(x = 10, y = 80, z = 10), <math>C(x = 10)10, y = 70, z = 20), D (x = 35, y = 45, z = 20), E (x = 20) 45, y = 45, z = 10) and F(x = 45, y = 55, z = 0) (and where w is in the range of $0.3 \le w < 1.0$ when the composition is on the line A-F) or on the lines in a ternary composition diagram having apexes represented by each component LiO_2 , $(\text{Si}_w \text{Ti}_{1-w}) \, \text{O}_2$ and MO (x, y and z are)represented by mol% and w is in the range of 0.3 \leq W \leq 1.0 when the component is on the line A-F,) are added, has a dielectric constant of as large as 1850, the rate of temperature dependent changes of the electrostatic capacitance satisfy the B-grade characteristic standard prescribed in the JIS standard in the temperature range from -25°C to +85°C, and satisfy the X7R-grade characteristic standard prescribed in the EIA standard in the temperature range from -55°C to +125°C. In addition, the rate of change of the capacitance when a DC voltage of 5 kV/mm is impressed is as small as within 43%, the change of the electrostatic capacitance being small when used as thin layers. The mean lifetime under the high temperature load test is as long as 80 hours or more, enabling a firing temperature of 1250°C.

When the compositions of the $\text{Li}_2\text{O-}(\text{Si}, \text{Ti})\,\text{O}_2\text{-Mo}$ based oxides are out of the range of the present invention as in the sample Nos. 113 to 117, 119, 121 and 122, on the contrary, sintering is insufficient to immediately cause short circuit troubles in the high temperature load test.

Example 3

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A dielectric powder material represented by the following formula was prepared using barium calcium titanate in TABLE 1-B:

 $(Ba_{0.90}Ca_{0.10}O)_{1.010} \cdot TiO_2 + 0.02Gd_2O_3 + 0.05MgO + 0.010MnO (molar ratio)$

Laminated ceramic capacitors were produced by the same method as used in Example 1, except that SiO_2-TiO_2-XO based oxides as the second sub-components (including those supplemented with Al_2O_3 and ZrO_2) as shown in TABLE 6 with a mean particle size of 1 μ m or less produced by heating at 1200 to 1500°C were added to the powder material above. The size and shape of the laminated ceramic capacitors produced are the same as in Example 1. Electric characteristics were measured by the same method as used in Example 1. The results are shown in TABLE 7.

		/eight	7r0.	701	0	0	0	0	0	0	0	0	0	0	0	5	0	0	0	0	0	15	0
	Additive	Parts by Weight	A1.0	131203	0	0	0	0	0	0	0	0	0	0	15	10	0	0	0	0	25	0	0
				Total	14	14	50	09	20	45	30	20	35	20	33	33	10	35	09	50	33	33	10
				MnO	6	4	1	5	0	30	0	4	0	5	0	0	0	5	0	0	0	0	0
				OuZ	4	0	4	13	10	15	0	0	0	5	0	0	0	5	5	0	0	0	0
		Composition (mol%)	ox	MgO	0	0	15	0	0	0	7	0	0	0	0	0	0	0	0	0	3	0	0
LE 6	mponen	osition		SrO	0	0	0	2	0	0	3	0	0	0	0	0	0	10	0	0	0	3	0
TABLE 6	Sub-Cor	Com		CaO	0	10	30	20	5	0	10	16	10	0	30	30	5	0	25	15	0	0	0
	Second Sub-Component			BaO	1	0	0	20	5	0	10	0	25	10	3	3	5	15	30	35	30	30	12
	0,1		Ė	1102	1	51	20	1	10	10	70	30	30	9	22	22	25	40	10	0	22	22	8
			6	SIO ₂	85	35	30	39	70	45	20	20	35	9	45	45	65	25	30	20	45	45	30
		Amount of	Addition	(parts by weight)	1	1	1	1	1	1	1	1	1	1	1	1	1	1	1	1	1	1	1
		Sample	No.		201	202	203	204	205	206	207	208	209	210	211	212	213	214	215	216	217	218	219

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	Mean Lifetime	(h)	92	96	88	85	91	95	88	92	88	85	96	92	1	ı	1	_	_	t	•
	Dielectric Breakdown	Voltage DC (kV/mm)	14	15	14	15	14	14	14	14	14	14	15	14	8	8	6	6	8	8	8
	Resistivity	$\log ho$ (Ω •cm)	13.2	13.2	13.3	13.2	13.2	13.4	13.3	13.3	13.3	13.3	13.5	13.6	11.2	11.1	11.4	11.3	11.5	11.4	11.2
	Rate of Temperature Dependent Change of Capacitance	$\Delta C/C25\%$ -55 ~ +125°C (%)	-11.2	-11.2	-11.6	-11.5	-11.5	-12.1	-11.7	-11.8	-11.9	-12.5	-11.1	-11.8	-12.1	-11.8	-12.5	-12.9	-11.7	-11.2	-12.2
TABLE 7	Rate of Temperature Dependent Change of Capacitance	ΔC/C20% -25~+85°C (%)	7.7-	-7.5	-8.1	-7.8	-8.1	-8.0	-8.1	-8.3	-8.1	-8.1	-7.5	-8.3	-7.2	-7.3	-7.2	-7.8	-7.1	9.9-	-7.1
	Rate of Change of	ΔC% DC 5Kv/mm	-41	-42	-42	-44	-41	-40	-43	-42	-43	-43	-41	-42	-42	-42	-40	-40	-38	-41	-40
	Dielectric I occ	tan ô (%)	2.4	2.3	2.4	2.3	2.3	2.2	2.3	2.3	2.3	2.3	2.2	2.3	3.1	2.9	2.7	2.7	2.9	2.8	3.1
	i de la companya de l	Constant	1940	1910	1950	1920	1930	1890	1910	1900	1930	1920	1880	1920	1620	1530	1460	1470	1430	1510	1480
	Burning	Temperature (°C)	1250	1250	1250	1250	1250	1250	1250	1250	1250	1250	1250	1250	1300	1300	1300	1300	1300	1300	1300
		No.	201	202	203	204	205	206	207	208	200	210	211	212	213	214	215	216	217	218	219

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As are evident from Table 6 and Table 7, the sample Nos. 201 to 210 in which SiO₂-TiO₂-XO based oxides with compositions within the area surrounded by the straight lines connecting between the succeeding two points represented by A (x = 85, y = 1, z = 14), B (x =35, y = 51, z = 14), C (x = 30, y = 20, z = 50) and D (x= 39, y = 1, z = 60) or on the lines in a ternary composition diagram having apexes represented by each component SiO_2 , TiO_2 and XO (x, y and z are represented by mol%) are added, has a dielectric constant of as large as 1890 or more, the rate of temperature dependent changes of the electrostatic capacitance satisfy the B-grade characteristic standard prescribed in the JIS standard in the temperature range from -25°C to +85°C, and satisfy the X7R-grade characteristic standard prescribed in the EIA standard in the temperature range from -55°C to +125°C. In addition, the rate of change of the capacitance when a DC voltage of 5 kV/mm is impressed is as small as within 44%, the change of the electrostatic capacitance being small when used as thin layers. mean lifetime under the high temperature load test is as long as 85 hours or more, enabling a firing temperature of 1250°C.

When the compositions of the SiO₂-TiO₂-XO based oxides are out of the range of the present invention as in the sample Nos. 213 to 216 and 219, on the contrary, sintering is insufficient, immediately causing short circuit troubles when a voltage is impressed in the high temperature load test.

While the resistivity can be enhanced by allowing ${\rm Al_2O_3}$ and ${\rm ZrO_2}$ in the ${\rm SiO_2\text{-}TiO_2\text{-}XO}$ based oxides as in the sample Nos. 211 and 212, sintering becomes insufficient when the amount of addition of ${\rm Al_2O_3}$ exceeds

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about 15 parts by weight or the amount of addition of ${\rm ZrO_2}$ exceeds about 5 parts by weight as in the sample Nos. 217 and 218, immediately causing short circuit troubles when a voltage is impressed in the high temperature load test.

When the dielectric ceramic particles of the samples having the compositions within the range of the present invention obtained in the Examples 1 to 3 were analyzed with a transmission electron microscope, coreshell structures in which the Re components (Re denotes Y, Gd, Tb, Dy, Ho, Er and Yb) are diffused in the vicinity of and at the grain boundary were confirmed.

As is evident from the foregoing descriptions, the dielectric ceramic layers in the laminated ceramic capacitor according to the present invention are composed of a dielectric ceramic composition that is not reduced even when they are fired in a reducing atmosphere. Therefore, base metals such as nickel and a nickel alloy can be used as electrode materials, along with making it possible to reduce the production cost of the laminated ceramic capacitor because the material is able to be fired at a relatively low temperature of 1250°C.

Reduction of the dielectric constant, or the electrostatic capacitance, is small even when a high electric field is impressed on the thin layer of the dielectric ceramic layer in the laminated ceramic capacitor using the dielectric ceramic composition, ensuring high reliability enough for obtaining a small size and thin layered laminated ceramic capacitor having large capacitance.

The dielectric ceramic layers 2a and 2b may be composed of a dielectric ceramic composition containing the principal components comprising barium calcium

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titanate $(Ba_{1-x}Ca_xO)_mTiO_2$, at least one or more of the oxides selected from Y_2O_3 , Gd_2O_3 , Tb_2O_3 , Dy_2O_3 , Ho_2O_3 , Er_2O_3 and Yb_2O_3 , MgO and MnO; and a sub-component selected from $\text{Li}_2\text{O}-\text{B}_2\text{O}_3-\text{(Si, Ti)}\,\text{O}_2$ based oxides, $\text{Al}_2\text{O}_3-\text{MO}-\text{B}_2\text{O}_3$ based oxides (MO is at least one oxide selected from BaO, CaO, SrO, MgO, ZnO and MnO) and SiO_2 . The composition described above allows the ceramic composition to be fired in a reducing atmosphere without endowing it with semiconductive properties. Consequently, a highly reliable laminated ceramic capacitor with high insulation resistance at room temperature and at high temperatures and having excellent insulation strength can be obtained while the temperature characteristics of the electrostatic capacitance satisfying the B-grade characteristics prescribed in the JIS standard and X7Rgrade characteristics prescribed in the EIA standard.

A highly reliable ceramic capacitor, in which the electric field dependent change of dielectric constant is small even when thin ceramic layers are placed in a high field intensity, can be obtained by using a barium calcium titanate material with a mean particle size of about 0.1 to 0.7 μ m. The dielectric ceramic has a core-shell structure in which Re components (Re is one or more of the elements selected from Y, Gd, Tb, Dy, Ho, Er and Yb) are distributed in the vicinity and at the grain boundaries due to diffusion during firing.

A highly reliable dielectric material is also obtainable by using a barium calcium titanate material containing about 0.02% by weight or less of alkali metal oxides such as Na_2O and K_2O .

Although the ratio (n) of (barium + calcium)/titanium in the barium calcium titanate material

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is not especially limited, the ratio (n) in the range from about 0.990 to 1.035 is desirable in order to diminish particle size distribution in the synthesize powder when stability for producing the powder material is taken into consideration.

The $\mathrm{Li_2O-B_2O_3-(Si,Ti)O_2}$ based oxides contained in the principal component allows the ceramic to be sintered at a relatively low temperature of 1250°C with no fear of deterioration of its characteristics due to plating. A much higher insulation resistance is obtained by allowing $\mathrm{Al_2O_3}$ and $\mathrm{ZrO_2}$ to be contained in the $\mathrm{Li_2O-B_2O_3-(Si,\,Ti)O_2}$ based oxides. The $\mathrm{Al_2O_3-MO-B_2O_3}$ based oxides contained in the principal component allows the ceramic to be easily sintered with no fear of deterioration of its characteristics due to plating. Further, $\mathrm{SiO_2}$ contained in the principal component also allows the ceramic to be easily sintered with no fear of deterioration of its characteristics due to plating.

The inner electrodes are composed of a base metal such as nickel and a nickel alloy.

The outer electrodes are composed of a sintered layer comprising various conductive metals such as Ag, Pd, Ag-Pd, Cu and a Cu alloy, or a sintered layer produced by blending the conductive metal powder with B_2O_3 -LiO₂-SiO₂-BaO based, B_2O_3 -SiO₂-BaO based, LiO₂-SiO₂-BaO based or B_2O_3 -SiO₂-ZnO based glass frits. Plating layers can be formed on this sintered layer. The plating layer may be merely composed of the first plating layer 6 comprising Ni, Cu or a Ni-Cu alloy, or a second plating layer 7 with a solder or tin may be formed thereon.

The foregoing method for producing the laminated ceramic capacitor can be also used when the materials described above are used.

Example 4

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TiO₂, BaCO₃ and CaCO₃ as starting materials were firstly prepared and mixed with crushing. The mixed powder was heated at 1000°C or more to synthesize nine kinds of barium calcium titanate shown in TABLE 1. Mean particle sizes were determined by observing the material under a scanning electron microscope.

Oxides, carbonates and hydroxides were weighed to be in the composition ratio of $0.25 \text{Li}_2\text{O}-0.10 \text{B}_2\text{O}_3$ - 0.07TiO_2 - 0.58SiO_2 (molar ratio) of the first subcomponent, and a powder was obtained by crushing with mixing. Likewise, oxides, carbonates and hydroxides were weighed to be in the composition ratio of $0.25 \text{Al}_2\text{O}_3$ - $0.17 \text{BaO}-0.03 \text{MnO}-0.55 \text{B}_2\text{O}_3$ (molar ratio) of the second subcomponent, and a powder was obtained by crushing with mixing. The powders of these first and second subcomponents were independently placed in crucibles to heat at $1400 \, ^{\circ}\text{C}$. Respective oxide powders with a mean particle size of 1 μm or less were obtained by quenching followed by crushing.

BaCO3 or TiO2, and Y2O3, Gd2O3, Tb2O3, Dy2O3, HO2O3, Er2O3, Yb2O3, MgO and MnO with purity of 99% or more were prepared for adjusting the molar ratio (m) of (Ba, Ca)/Ti in barium calcium titanate. These powder materials, and the oxide powders as the first and second sub-components were weighed to be the compositions shown in TABLE 8. The first and second sub-components were added in parts by weight relative to 100 parts by weight of the principal component (Ba1-xCaxO)mTiO2 + α Re2O3 + β MgO + γ MnO. A polybutyral based binder and an organic solvent such as ethanol were added into the weighed mixture, which was wet-milled to prepare a ceramic slurry. This ceramic

slurry was formed into a sheet by a doctor blade method, obtaining a rectangular green sheet with a thickness of 4.5 μm . A conductive paste mainly composed of Ni was printed on this green sheet to form conductive paste layers constituting the inner electrodes.

	First Sub-	-		0.02 0.005 1 0	0.02 0.005 1 0	0.02 0.005 1 0	0.02 0.005 1 0	0.008 0.005 1 0	0.13 0.005 1 0	0.02 0.0008 1 0	0.02 0.13 1 0	0.02 0.005 1 0	0.02 0.005 1 0	0.02 0.005 1 0	0.02 0.005 0 0	0.02 0.1 0 0	0.02 0.005 5.5 0	0.02 0.005 0 5.5	0.02 0.005 1 0	0.02 0.005 1 0	0.02 0.005 1 0	0.02 0.005 0 1	
			Yb_2O_3	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	
	/MnO		Er_2O_3	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	
TABLE 8	βMgO+1		Ho ₂ O ₃	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	,
TA]	$_{x}$ CaxO)m $ullet$ TiO $_{2}+lpha$ Re $_{2}$ O $_{3}+eta$ MgO+ γ MnO	α	Dy_2O_3	0.02	0.02	0.0005	0.11	0.05	0.02	0.02	0.02	0.02	0.02	0.02	0.02	0.02	0.02	0.02	0.02	0.02	0.02	0	(
	•TiO ₂ +o		Tb_2O_3	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	
	.xCaxO)m		Gd_2O_3	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	000
	(Ba ₁		Y_2O_3	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0.025	(
			=	1.01	1.01	1.01	1.01	1.01	1.01	1.01	1.01	0.995	1	1.036	1.01	1.01	1.01	1.01	1.01	1.01	1.01	1.025	3
		*	<	0.003	0.250	0.100	0.100	0.100	0.100	0.100	0.100	0.100	0.100	0.100	0.100	0.100	0.100	0.100	0.100	0.100	0.100	0.100	00,
		Kind of Barium	Calcium Titanate	A	Ω	В	В	В	В	В	В	В	В	В	В	В	В	В	В	Н	I	ß	
		Sample No.		1001*	1002*	1003*	1004*	1005*	1006*	1007*	1008*	1009*	1010*	1011*	1012*	1013*	1014*	1015*	1016*	1017	1018	1019	

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	Second Sub-	Component (parts by	weight)	0	0	1	1	1	0	2
	First Sub-	Component (parts by	weight)	3	2	0	0	0	2	0
		λ		0.005	0.05	0.05	0.05	0.005	0.005	0.005
		β		0.05	0.02	0.02	0.02	0.02	0.02	0.02
			Yb_2O_3	0	0	0	0.03	0	0	0
ī	MnO		$\mathrm{Er}_2\mathrm{O}_3$	0	0	0.02	0	0	0	0
TABLE 8 - Cont'd	$3MgO + \gamma$		Ho ₂ O ₃	0	0.02	0	0	0	0	0
TABLE	$(Ba_{1,x}CaxO)m\bullet TiO_2 + \alpha Re_2O_3 + \beta MgO + \gamma MnO$	α	Dy ₂ O ₃	0	0	0	0	0.02	0	0.02
	$-\text{TiO}_2 + \alpha$		Tb ₂ O ₃	0.05	0	0	0	0	0	0
	CaxO)m		Gd ₂ O ₃	0	0	0	0	0	0.015	0
	(Ba ₁		Y_2O_3	0	0	0	0	0.005	0.005	0
			E	1.015	1.01	1.01	1.005	1.005	1.015	1.015
			×	0.100 1.015	0.100	0.100	0.200	0.200	080.0	0.080
		Kind of Barium	Calcium Titanate	ß	В	В	C	၁	F	Ь
		Sample	INO.	1021	1022	1023	1024	1025	1026	1027

* The Samples marked by (*) are out of the range of the present invention.

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Next, a plurality of ceramic green sheets on which the conductive paste layers had been formed were laminated to obtain a laminated body so that the sides where the conductive paste layers are alternately exposed come to the opposite ends. The laminated body was heated at a temperature of 350°C in a N_2 atmosphere. After driving out the binder, the laminated body was fired in a reducing atmosphere comprising a H_2 - N_2 - H_2 O gas with an oxygen partial pressure of 10^{-9} to 10^{-12} MPa to obtain a ceramic sintered body.

After firing, an Ag paste containing a $\rm B_2O_3$ - $\rm Li_2O\text{-}SiO_2\text{-}BaO$ based glass frit was coated on both side faces of the ceramic sintered body, which was baked at a temperature of 600°C in the $\rm N_2$ atmosphere to form the outer electrodes electrically connected to the inner electrodes.

A plating solution comprising nickel sulfate, nickel chloride and boric acid was prepared, and nickel plating layers were formed on the silver outer electrodes by a barrel plating method. Then, a solder plating solution comprising an AS (alkano-sulfonic acid) bath was prepared and a solder plating was applied on the nickel plating layer by the barrel plating method, obtaining a laminated ceramic capacitor in which the outer electrodes were covered with plating layers.

The laminated ceramic capacitor obtained as described above had an overall dimension with a width of 5.0 mm, a length of 5.7 mm and a thickness of 2.4 mm, the thickness of the effective dielectric ceramic layer inserted between the inner electrodes being 3 μ m. The total number of the effective dielectric ceramic layers was five with an area of the confronting electrode per layer of 16.3 \times 10⁻⁶ m².

The electric characteristics of these laminated ceramic capacitors were then determined. The methods for measuring the electrostatic capacitance, dielectric loss (tan δ), insulation resistance, DC bias characteristics and temperature dependency (rate of change) of the electrostatic capacitance, the content of the high temperature load test, and the method for measuring dielectric breakdown voltage were the same as hitherto described. The results are listed in TABLE 9.

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	Mean Lifetime	(h)	3	26	1	21	74	3	3	5	-	l	1	-	1	7	5	18	54	162	108
	Dielectric Breakdown Voltage	DC (kV/mm)	14	15	14	15	14	14	13	14	6	6	10	11	12	14	14	14	14	14	14
	Resistivity Log o	Ω•cm)	13.1	13.1	13.2	13.3	12.6	13.1	11.7	12.1	11.4	11.5	12.2	11.5	11.7	13.2	13.1	13.1	13.2	13.4	13.2
	Rate of Temperature Dependent Change of Capacitance	$\Delta C/C25\%$ -55 ~ +125°C (%)	-15.6	-6.1	-9.7	-23.4	-22.9	-14.2	-14.8	-14.7	-19.6	-18.4	-14.7	-14.1	-14.5	-29.5	-27.7	-15.4	T.T-	-14.3	-14.7
TABLE 9	Rate of Te Dependent Capac	ΔC/C20% -25~+85°C (%)	-9.5	-4.3	-3.3	-18.4	-14.8	-6.7	-9.4	9.5	-12.4	-12.7	-9.3	-9.2	-9.3	-13.8	-13.5	-10.8	-5.1	T.T-	7.6-
	Rate of Change of Capacitance	ΔC% DC 5Kv/mm	99-	-33	-57	-41	-59	-41	-44	-41	-55	-58	-51	-47	-48	-47	-45	-45	-52	-31	-33
	Dielectric Loss	tan ô (%)	3.8	9.5	5.1	3.6	3.3	3.7	2.8	2.7	3.9	4.7	4.4	5.3	5.2	3.5	3.3	3.7	3.4	2.3	2.4
	Dielectric	Constant	3310	1090	2540	1200	2470	1570	1890	1830	2070	2050	1950	1610	1630	1570	1680	1750	2470	1050	1450
	Burning	(°C)	1300	1250	1250	1250	1250	1350	1250	1250	1250	1250	1300	1350	1350	1200	1200	1250	1250	1150	1175
		No.	*1001	*1002	*1003	*1004	*1005	*1006	*1007	*1008	*1009	*1010	*1011	*1012	*1013	*1014	*1015	*1016	1017	1018	1019

	Mean Lifetime	(h)	111	107	83	81	110	120	91	94
	U	vonage DC (kV/mm)	15	14	14	14	14	14	14	14
		Log ρ (Ω•cm) (k	13.3	13.3	13.2	13.3	13.1	13.2	13.2	13.2
p,		ΔC/C25% -55~+125°C (%)	-14.3	-14.8	-12.8	-12.5	-10.2	-10.8	-14.3	-14.7
TABLE 9 - Cont'd	Rate of Temperature Dependent Change of Capacitance	$\Delta C/C20\%$ -25 ~ +85°C (%)	-9.4	-9.5	-8.5	-8.5	-7.1	8-9-	7.6-	8.6-
	Rate of Change of Capacitance	ΔC% DC 5Kv/mm	-31	-32	-41	-43	-37	-35	-33	-32
	Dielectric Loss	tan δ (%)	2.3	2.5	2.5	2.4	2.5	2.5	2.4	2.1
	Dielectric	Constant	1260	1310	1920	1990	1430	1450	1160	1270
	Burning	(°C)	1150	1175	1200	1250	1250	1250	1175	1175
	Sample	No.	1020	1021	1022	1023	1024	1025	1026	1027

* The Samples marked by (*) are out of the range of the present invention.

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The cross section of the laminated ceramic capacitor was polished and subjected to chemical etching to observe the grain diameter of the dielectric ceramic under a scanning electron microscope. It was found that the grain diameter was almost equal to the particles size of the barium calcium titanate material in the samples having the compositions within the range of the present invention.

As is evident from TABLE 8 and TABLE 9, the rate of temperature dependent changes of the electrostatic capacitance in the laminated ceramic capacitor according to the present invention satisfies the B-grade characteristic standard prescribed in the JIS standard in the temperature range from -25°C to +85°C and the X7R grade characteristic standard prescribed in the EIA standard in the temperature range from -55°C to +125°C. Moreover, the rate of change of the capacitance under an impressed DC voltage of 5 kV/mm is as small as 52%, indicating that the change of the electrostatic capacitance is also small when thin layers are used in the capacitor. The mean lifetime in the high temperature load test is as long as 45 hours, enabling one to fire at a temperature of 1250°C or less.

The reasons why the compositions are limited will be described hereinafter.

In the system comprising the principal component;

 $(\text{Ba}_{1\text{-x}}\text{Ca}_{x}\text{O})_{m}\text{TiO}_{2} + \alpha \text{Re}_{2}\text{O}_{3} + \beta \text{MgO} + \gamma \text{MnO}$ $(\text{Re}_{2}\text{O}_{3} \text{ is at least one or more of the compounds selected}$ from Y_{2}O_{3} , $\text{Gd}_{2}\text{O}_{3}$, $\text{Tb}_{2}\text{O}_{3}$, $\text{Dy}_{2}\text{O}_{3}$, $\text{Ho}_{2}\text{O}_{3}$, $\text{Er}_{2}\text{O}_{3}$ and $\text{Yb}_{2}\text{O}_{3}$; α , β and γ representing molar ratios), the first and the second sub-components, the content (x) of CaO of about 0.05 or less as in the sample No. 1001 is not preferable since

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the rate of impressed voltage dependent change of the capacitance is large and the mean lifetime is extremely shortened. A content (x) of CaO exceeding about 0.22 as in the sample No. 1002 is not preferable, on the other hand, since the dielectric loss is increased. Accordingly, the preferable CaO constant (x) is in the range of 0.005 $< x \le 0.22$.

It is not preferable that the Re_2O_3 content (α) is less than about 0.001 as in the sample No. 1003 since the mean lifetime is extremely shortened. A Re_2O_3 content (α) of exceeding about 0.10 as in the sample No. 1004 is also not preferable, on the other hand, since the temperature characteristics do not satisfy the B/X7R grade characteristics and the mean lifetime is shortened. Accordingly, the preferable Re_2O_3 content (α) is in the range of 0.001 $\leq \alpha \leq 0.10$.

It is not preferable that the MgO content (β) is less than about 0.001 as in the sample No. 1005 since the temperature characteristics do not satisfy the B/X7R grade characteristics. A MgO content (β) of exceeding about 0.12 as in the sample No. 1006 is also not preferable, on the other hand, since the sintering temperature becomes so high that the mean lifetime is extremely shortened. Accordingly, the preferable MgO content (β) is in the range of 0.001 $\leq \beta \leq$ 0.12.

It is not preferable that the MnO content (γ) is about 0.001 or less as in the sample No. 1007 since the resistivity is lowered and the mean lifetime is extremely shortened. A MnO content (γ) of exceeding about 0.12 as in the sample No. 1008 is also not preferable, on the other hand, since the mean lifetime is extremely shortened. Accordingly, the preferable MnO content (γ) is in the range of 0.001 $<\gamma \le 0.12$.

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It is not preferable that the ratio (m) of (Ba, ca)/Ti is about 1.000 or less as in the sample Nos. 1009 and 1010 since the temperature characteristics do not satisfy the B/X7R grade characteristics and the resistivity becomes low and short circuit troubles are immediately caused when a voltage is impressed in the high temperature load test. It is also not preferable, on the other hand, that the ratio (m) of (Ba, ca)/Ti exceeds about 1.035 as in the sample No. 1011 because sintering becomes insufficient to extremely shorten the mean lifetime. Accordingly, the preferable ratio (m) of (Ba, ca)/Ti is in the range of 1.000 < m < 1.035.

It is not preferable that the content of the first and second sub-component is zero as in the sample Nos. 1012 and 1013 since the resistivity becomes low along with immediately causing circuit troubles when a voltage is impressed in the high temperature load test. It is also not preferable, on the other hand, that the content of the first and second sub-components exceed about 5.0 parts by weight as in the sample Nos. 1014 and 1015 because an increased amount of the secondary phase is formed and the temperature characteristics do not satisfy the B/X7R grade characteristics, extremely shortening the mean lifetime. Accordingly, the content of either the first sub-component or the second sub-component is preferably in the range from 0.2 to 5.0.

The content of alkali metal oxides that are contained in barium calcium titanate as impurities is adjusted to about 0.02% by weight or less because, as in the sample No. 1016, the mean lifetime is shortened when the content of the alkali metal oxides exceeds about 0.02% by weight.

The sample No. 1017 in which the mean particle size of barium calcium titanate exceeds 0.7 μm shows a little poor mean lifetime of 52 hours. The sample No. 1018 in which the mean particle size of barium calcium titanate is less than 0.1 μm shows, on the other hand, a little smaller dielectric constant of 1050. Accordingly, the preferable mean particle size of barium calcium titanate is in the range from about 0.1 to 0.7 μm .

Example 5

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10 Starting materials TiO₂, BaCO₃ and CaCO₃ were firstly prepared and mixed with crushing as in Example 4. The mixed powder was heated at 1000°C or more to synthesize nine kinds of barium calcium titanate shown in TABLE 1. Mean particle sizes were determined by observing the material under a scanning electron microscope. SiO₂ was also prepared as a third subcomponent.

BaCO $_3$ or TiO $_2$ for adjusting the molar ratio (m) of (Ba, Ca)/Ti, and Y $_2$ O $_3$, Gd $_2$ O $_3$, Tb $_2$ O $_3$, Dy $_2$ O $_3$, Ho $_2$ O $_3$, Er $_2$ O $_3$, Yb $_2$ O $_3$, MgO and MnO with purity of 99% or more were prepared. These powder materials and the SiO $_2$ powder as the third sun-component were weighed to be the compositions shown in TABLE 10. The amount of addition of SiO $_2$ is expressed in parts by weight relative to 100 parts by weight of the principal component (Ba $_1$,Ca $_x$ O) $_m$ TiO $_2$ + α Re $_2$ O $_3$ + β MgO + γ MnO.

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	Third Sub-	Component SiO, (parts by	weight)	1	1	1	1	1	1	1	1	1	1	1	0	0	5.5		1	1	1	4	3
		>	,	0.005	0.005	0.005	0.005	0.005	0.005	0.0008	0.13	0.005	0.005	0.005	0.005	0.1	0.005	0.005	0.005	0.005	0.005	0.008	0.005
		æ	2.	0.02	0.02	0.02	0.02	0.0008	0.13	0.02	0.02	0.02	0.02	0.02	0.02	0.02	0.02	0.02	0.02	0.02	0.02	0.05	0.05
			Yb_2O_3	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
	Q		$\mathrm{Er}_2\mathrm{O}_3$	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
	$(Ba_{1-x}Ca_xO)_m \bullet TiO_2 + \alpha Re_2O_3 + \beta MgO + \gamma MnO$		Ho_2O_3	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
TABLE 10	$^{2}O_{3} + \beta M$	α	Dy_2O_3	0.02	0.02	0.0005	0.11	0.02	0.02	0.02	0.02	0.02	0.02	0.02	0.02	0.02	0.02	0.02	0.02	0.02	0	0	0
TA	ΓiO ₂ +αRe		Tb_2O_3	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0.05
	$(Ca_xO)_m^{\bullet}$		Gd_2O_3	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0.08	0
	(Ba ₁₋		Y_2O_3	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0.025	0	0
		ξ	1	1.01	1.01	1.01	1.01	1.01	1.01	1.01	1.01	0.995	1	1.036	1.01	1.01	1.01	1.01	1.01	1.01	1.025	1.02	1.015
		>	<	0.003	0.250	0.100	0.100	0.100	0.100	0.100	0.100	0.100	0.100	0.100	0.100	0.100	0.100	0.100	0.100	0.100	0.100	0.100	0.100
		Kind of Barium	Calcium Titanate	A	D	В	В	В	В	В	В	В	В	В	В	В	В	田	Н	I	G	G	G
		Sample No.		*1101	*1102	*1103	*1104	*1105	*1106	*1107	*1108	*1109	*1110	*1111	*1112	*1113	*1114	*1115	1116	1117	1118	1119	1120

	Third Sub-	Component SiO ₂ (parts by	weight)	2	1	1	1	1	0.5
		5		0.05	0.05	0.05	0.005	0.005	0.005
		ď	2	0.02	0.02	0.02	0.02	0.02	0.02
			Yb_2O_3	0	0	0.03	0	0	0
	0		$\mathrm{Er}_2\mathrm{O}_3$	0	0.02	0	0	0	0
ıt'd	gO+γMn		Ho_2O_3	0.02	0	0	0	0	0
TABLE 10 - Cont'd	$^{2}O_{3} + \beta M_{3}$	α	Dy_2O_3	0	0	0	0.02	0	0.02
TABLE	$^{1}O_{2}+\alpha Re$		Tb_2O_3	0	0	0	0	0	0
	$\overline{(Ba_{1,x}Ca_{x}O)_{m}}\bullet TiO_{2}+\alpha Re_{2}O_{3}+\beta MgO+\gamma MnO$		Gd ₂ O ₃ Tb ₂ O ₃ Dy ₂ O ₃	0	0	0	0	0.015	0
	(Ba ₁₋ ,		Y_2O_3	0	0	0	0.005	0.005	0
			<u> </u>	1.01	1.01	1.005	1.005	1.015	0.080 1.015
		;	×	0.100	0.100	0.200	0.200	080.0	0.080
		Kind of Barium	Calcium Titanate	В	В	C	S	F	Ħ
		Sample		1121	1122	1123	1124	1125	1126

The samples marked by () are out of the range of the present invention.

Laminated ceramic capacitors were then produced by the same method as in Example 4. The size and shape of the laminated ceramic capacitors produced were the same as those in Example 4. The electric characteristics were measured by the same method as used in Example 1, the results of which are shown in TABLE 11.

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	Mean Lifetime	(h)	4	21	т.	11	13	1	14	7	1	-	2	1	1	4	10	62	190	68	109
	Dielectric Breakdown Voltage	(kV/mm)	15	14	14	15	11	15	14	14	9	8	8	11	8	14	14	13	15	15	14
	Resistivity	ωs κ (Ω•cm)	13.1	13.2	13.3	13.5	11.5	13.1	11.2	11.4	11.2	11.7	12.4	11.1	11.3	13.2	13.1	13.2	13.3	13.4	13.2
	Rate of Temperature Dependent Change of Capacitance	ΔC/C25% -55~+125°C (%)	-15.4	-6.7	-10.6	-13.5	-25.1	-15.1	-15.3	-20.1	-19.2	-17.2	-14.1	-13.5	14.0	-29.8	-16.5	-6.5	-14.9	-14.2	-14.1
TABLE 11	Rate of Te Dependent Capac	$\Delta C/C20\%$ -25 ~ +85 °C (%)	8.6-	-4.5	-1.7	-18.2	-15.5	6.7-	-9.2	-14.1	-12.3	-12.5	-9.0	-8.7	-8.7	-15.2	-15.1	-4.8	-10.2	-9.4	-8.7
	Rate of Change of Capacitance	ΔC% DC 5Kv/mm	89-	-33	<i>LS-</i>	-57	-65	-48	-56	-54	-59	-63	-52	-44	-47	-49	-59	-52	-31	-34	-34
	Dielectric Loss	tan δ (%)	3.0	9.4	2.1	2.9	2.5	2.7	2.2	2.4	4.5	2.8	3.1	3.5	3.9	2.8	2.2	1.7	2.1	2.1	2.4
	Dielectric	Constant	1340	1110	2410	1250	2610	1820	1910	1700	2050	1980	2070	1530	1510	1720	1710	2900	1130	1400	1270
	Burning	(°C)	1300	1250	1250	1250	1250	1350	1250	1250	1250	1250	1300	1350	1350	1200	1250	1250	1150	1175	1150
		No.	*1101	*1102	*1103	*1104	*1105	*1106	*1107	*1108	*1109	*1110	*1111	*1112	*1113	*1114	*1115	1116	1117	1118	1119

	Mean Lifetime	(h)	100	84	76	115	132	68	86
	Dielectric Breakdown Voltage	(kV/mm)	14	15	14	14	14	15	15
	Resistivity	ωg μ (Ω•cm)	13.1	13	13.3	13.1	13	13.2	13.2
	Rate of Temperature Dependent Change of Capacitance	$\Delta C/C25\%$ -55 ~ +125°C (%)	-14.3	-13.5	-13.2	-11.8	-11.0	-14.3	-13.7
TABLE 11 - Cont'd	Rate of Te Dependent Capac	ΔC/C20% -25~+85°C (%)	-9.3	8.8-	6.7-	-8.1	6.7-	8.6-	-9.2
TAB	Rate of Change of Capacitance	ΔC% DC 5Kv/mm	-35	-43	-41	-35	-30	-33	-31
	Dielectric Loss	tan ô (%)	2.3	2.0	2.1	2.3	2.4	2.1	2.0
	Dielectric	Constant	1270	1910	2030	1410	1420	1270	1310
	Burning	l emperaure (°C)	1175	1200	1250	1250	1250	1175	1175
	Sample	No.	1120	1121	1122	1123	1124	1125	1126

* The samples marked by (*) are out of the range of the present invention.

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The grain size of the polished cross section of the laminated ceramic capacitor obtained was determined under a scanning electron microscope after chemical etching, finding that the grain size was almost equal to the particle size of the barium calcium titanate as a starting material in the samples having the compositions within the range of the present invention.

As is evident from TABLE 10 and TABLE 11, the rate of temperature dependent change of the laminated ceramic capacitor according to the present invention satisfies the B-grade characteristic standard prescribed in the JIS standard in the temperature range from -15°C to +85°C and the X7R-grade characteristic standard prescribed in the EIA standard in the temperature range from -55°C to +125°C. Moreover, the rate of change of the capacitance under an impressed DC voltage of 5 kV/mm is as small as 52%, indicating that the change of the electrostatic capacitance is also small when the capacitor is used as a thin layer. The mean lifetime in the high temperature load test is as long as 62 hours, enabling one to fire at a temperature of 1250°C or less.

The reason why the compositions according to the present invention are limited in the present invention will be described hereinafter.

In the system comprising the principal component

 $(\text{Ba}_{1\text{-x}}\text{Ca}_x\text{O})_m\text{TiO}_2 + \alpha \text{Re}_2\text{O}_3 + \beta \text{MgO} + \gamma \text{MnO} \\ (\text{Re}_2\text{O}_3 \text{ represents at least one of the compounds selected} \\ \text{from } Y_2\text{O}_3, \text{ Gd}_2\text{O}_3, \text{ Tb}_2\text{O}_3, \text{ Dy}_2\text{O}_3, \text{ Ho}_2\text{O}_3, \text{ Er}_2\text{O}_3 \text{ and } \text{Yb}_2\text{O}_3 \text{ and } \alpha, \beta \\ \text{and } \gamma \text{ represent molar ratios)} \\ \text{and the third subcomponent, a content } (x) \text{ of CaO of about 0.005 or less as in the sample No. 1101 is not preferable since the rate of impressed voltage dependent change of the capacitance} \\ \text{ of impressed voltage dependent change of the capacitance} \\ \text{ o$

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becomes large besides the mean lifetime becomes extremely short. It is also not preferable that the content (x) of CaO exceeds about 0.22 as in the sample No. 1102 because the dielectric loss is increased. Accordingly, the preferable CaO content (x) is in the range of 0.005 < $x \le 0.22$.

A $\mathrm{Re_2O_3}$ content (α) of less than about 0.001 as in the sample No. 1103 is also not preferable because the mean lifetime becomes extremely short. It is also not preferable that the content of $\mathrm{Re_2O_3}$ (α) exceeds about 0.10 as in the sample No. 1104 since the temperature characteristics do not satisfy the B/X7R-grade characteristics while the mean lifetime is shortened. Accordingly, the preferable $\mathrm{Re_2O_3}$ content (α) is in the range of 0.001 $\leq \alpha \leq$ 0.10.

A MgO content (β) of less than about 0.001 as in the sample No. 1105 is also not preferable because the rate of impressed voltage dependent change of the capacitance becomes large, the temperature characteristics do not satisfy the B/X7R-grade characteristics and the resistivity is lowered, shortening the mean lifetime. It is also not preferable, on the other hand, that the amount of addition (β) of MgO exceeds about 0.12 as in the sample No. 1106 since the sintering temperature becomes high to extremely shorten the mean lifetime. Accordingly, the preferable MgO content (β) is in the range of 0.001 $\leq \beta \leq$ 0.12.

A MnO content (γ) of less than about 0.001 as in the sample No. 1107 is also not preferable because the resistivity is low while the mean lifetime is shortened. It is also not preferable, on the other hand, that the MnO content (γ) exceeds about 0.12 as in the sample No. 1108 since the temperature characteristics do not satisfy

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the B/X7R-grade characteristics, the resistivity becomes low and the mean lifetime is shortened. Accordingly, the preferable range of the MnO content (γ) is $0.001 \le \gamma \le 0.12$.

It is not preferable that the ratio (m) of (Ca, Ca)/Ti is less than about 1.000 as in the sample Nos. 1109 and No. 1110 because the temperature characteristics do not satisfy the B/X7R-grade characteristics and the resistivity is lowered, immediately causing short circuit troubles when a voltage is impressed in the high temperature load test. It is also not preferable, on the other hand, that the ratio (m) of (Ca, Ca)/Ti exceed about 1.035 as in the sample No. 1111 because sintering is insufficient to extremely shorten the mean lifetime. Accordingly, the preferable ratio (m) of (Ca, Ca)/Ti is in the range of 1.000 < m \leq 1.035.

It is not preferable that the contents of the first and second sub-components are zero as in the samples No. 1112 and No. 1113 because the resistivity is lowered to immediately cause short circuit troubles when a voltage is impressed in the high temperature load test. It is also not preferable, on the other hand, that the contents of the first and second sub-components exceed about 5.0 parts by weight as in the sample No. 1114 because the second phase based on glass components is increased besides the temperature characteristics do not satisfy the B/X7R-grade characteristics and the mean lifetime is extremely shortened. Accordingly, the preferable content of either the first component or the second component is in the range from about 0.2 to 5.0 parts by weight.

The content of the alkali metal oxides contained in barium calcium titanate as impurities is

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adjusted to about 0.02% by weight or less because when the content of the alkali metal oxides exceeds about 0.02% by weight as in the sample No. 1115, the mean lifetime is shortened.

The sample No. 1116 in which the mean particle size of barium calcium titanate exceeds about 0.7 μm shows a little poor mean lifetime of 52 hours. The sample No. 1117 in which the mean particle size of barium calcium titanate is less than about 0.1 μm shows, on the other hand, a little smaller dielectric constant of 1130. Accordingly, the preferable mean particle size of barium calcium titanate is in the range from 0.1 to 0.7 μm .

Example 6

A starting material having the following composition was prepared as a dielectric powder using barium calcium titanate (B) as shown in TABLE 12:

 $(Ba_{0.90}Ca_{0.10}O)_{1.010} \cdot TiO_2 + 0.02Dy_2O_3 + 0.02MgO + 0.010MnO (molar ratio)$

Laminated ceramic capacitors were produced by the same method as used in Example 1, except that the $\text{Li}_2\text{O-B}_2\text{O}_3$ -(Si, Ti)O₂ based oxide (including those supplemented with Al_2O_3 and ZrO_2) as the first subcomponent with a mean particle size of 1 μm or less produced by heating at 1200 to 1500°C was added to the powder material. The size and shape of the laminated ceramic capacitor produced are the same as that produced in Example 4. The electric characteristics were measured by the same method as in Example 4, the results of which are shown in TABLE 13.

			TABI	LE 12			
		First Su	ibcompo	nent		Add	itive
Sample. No.	Amount of addition	Comp	osition (mol%, excep	ot w)	Parts by	Weight
	(parts by weight)	Li ₂ O	B_2O_3	(Si _w Ti _{1-w})	w	Al_2O_3	ZrO
1201	1	0	20	80	0.7	0	0
1202	1	19	1	80	0.7	0	0
1203	1	49	1	50	0.8	0	0
1204	2	45	50	5	0.5	0	0
1205	2	20	75	5	0.4	0	0
1206	2	0	80	20	0.4	0	0
1207	1.5	35	15	50	0.5	0	0
1208	1.5	35	50	15	0.9	0	0
1209	2	20	40	40	0.3	0	0
1210	2	10	15	75	0.7	0	0
1211	2	10	70	20	0.4	5	2
1212	2	35	15	50	0.7	15	5
1213	2	35	15	50	0.7	20	0
1214	2	35	15	50	0.7	0	10
1215	3	10	5	85	0.5	0	0
1216	3	55	20	25	0.7	0	0
1217	3	35	62	3	0.7	0	0
1218	2	5	85	10	0.7	0	0
1219	2	10	15	75	0.1	0	0
1220	2	35	50	15	1	0	0
1221	2	35	50	15	0.7	30	0
1222	1	35	50	15	0.7	0	20

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				TA	TABLE 13				
Ę	Burning	Dielectric	Dielectric Loss	Rate of Change of Capacitance	Rate of T Dependent Capac	Rate of Temperature Dependent Change of Capacitance	Resistivity	Dielectric Breakdown	Mean
2	(°C)	Constant	tan δ (%)	ΔC% DC 5Kv/mm	$\Delta C/C20\%$ -25 ~ +85°C (%)	ΔC/C25% -55~+125°C (%)	(N•cm)	(kV/mm)	(h)
	1250	1880	2.4	-42	-7.8	-12.5	13.0	13	81
	1250	1870	2.4	-43	9.7-	-12.4	13.1	13	88
	1250	1850	2.3	-42	-7.8	-12.4	13.1	13	83
	1225	1830	2.3	-41	7.7-	-12.1	13.1	13	85
l	1225	1860	2.5	-41	-7.1	-12.1	13.0	13	84
	1225	1840	2.4	-40	-8.1	-12.5	13.1	13	80
	1250	1880	2.4	-43	-8.0	-11.8	13.0	13	98
	1250	1900	2.5	-45	-8.3	-12.7	13.0	12	88
•	1225	1850	2.4	-44	7.7-	-12.3	13.1	13	83
	1225	1870	2.4	-45	6.7-	-12.5	13.0	13	83
l	1225	1880	2.4	-44	-8.0	-12.6	13.3	14	91
	1225	1860	2.3	-44	-8.5	-12.5	13.3	14	97
	1225	1810	2.2	-43	-8.2	-12.4	13.4	14	95
	1225	1780	2.2	-43	-7.5	-12.1	13.3	14	92
	1350	1650	4.3	-42	-7.2	-11.7	11.1	12	2
	1350	1770	4.1	-42	-7.4	-11.8	11.4	10	7
	1300	1580	3.5	-41	-7.3	-11.3	11.6	11	26
	1300	1870	3.4	-44	-7.8	-11.8	11.8	11	18
	1350	1830	4.7	-44	7.7-	-12.1	11.1	11	4

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	Mean	(h)	22	1	2
	Dielectric Breakdown	voltage DC (kV/mm)	12	12	12
	Resistivity	LOS ρ (Ω•cm)	12.4	10.8	10.7
	Rate of Temperature Dependent Change of Capacitance	$\Delta C/C25\%$ -55 ~ +125°C (%)	-12.7	-12.6	-13.4
TABLE 13 - Cont'd	Rate of T Dependen Capa	ΔC/C20% -25~+85°C (%)	-8.1	6.7-	-8.3
TABL	Rate of Change of Capacitance	AC% DC 5Kv/mm	-45	-44	-45
	Dielectric Loss	tan <i>δ</i> (%)	3.9	4.7	5.6
	Dielectric	Constant	1910	1880	1920
	Burning [(°C)	1300	1350	1350
	Sample	No.	1220	1221	1222

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As is evident from TABLE 12 and TABLE 13, the sample Nos. 1201 to 1210, in which $\text{Li}_2\text{O}-\text{B}_2\text{O}_3-(\text{Si}_w\text{Ti}_{1-w})\text{O}_2$ based oxides with compositions within the area surrounded by the straight lines connecting between the succeeding two points represented by A (x = 0, y = 20, z = 80), B (x = 0, y = 20, z = 80)= 19, y = 1, z = 80), C (x = 49, y = 1, z = 50), D (x =45, y = 50, z = 5), E (x = 20, y = 75, z = 5) and F (x = 5) 0, y = 80, z = 20) or on the lines in a ternary composition diagram having apexes represented by each component Li_2O , B_2O_3 and $\text{Si}_w\text{Ti}_{1\text{-w}}\text{O}_2$ (x, y and z are represented by mol%) are added, has a dielectric constant of as large as 1830 or more, the rate of temperature dependent changes of the electrostatic capacitance satisfy the B-grade characteristic standard prescribed in the JIS standard in the temperature range from -25°C to +85°C, and satisfy the X7R-grade characteristic standard prescribed in the EIA standard in the temperature range from -55°C to +125°C. In addition, the rate of change of the capacitance when a DC voltage of 5 kV/mm is impressed is as small as within 45%, the change of the electrostatic capacitance being small when used as thin layers. The mean lifetime under the high temperature load test is as long as 80 hours or more, enabling a firing temperature of 1250°C.

When the content of the $\text{Li}_2\text{O-B}_2\text{O}_3\text{-}(\text{Si}, \text{Ti})\text{O}_2$ based oxide is out of the range of the present invention as in the sample Nos. 1215 and 1220, on the contrary, sintering is insufficient or electric characteristics are deteriorated due to plating after firing, shortening the mean lifetime in the high temperature load test.

While the resistivity can be enhanced by allowing Al_2O_3 and ZrO_2 to be contained in the $Li_2O-B_2O_3-(Si,\ Ti)O_2$ based oxide as in the sample Nos. 1211 and

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1214, sintering becomes insufficient to shorten the mean lifetime in the high temperature load test as in the sample Nos. 1221 and 1222 when the amount of addition of $\mathrm{Al}_2\mathrm{O}_3$ exceeds 20 parts by weight or the amount of addition of ZrO2 exceeds 10 parts by weight.

Example 7

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A starting material having the following composition was prepared as a dielectric powder using barium calcium titanate (B) as shown in TABLE 14:

> $(Ba_{0.90}Ca_{0.10}O)_{1.010} \cdot TiO_2 + 0.02Gd_2O_3 + 0.05MgO +$ 0.010MnO (molar ratio)

Laminated ceramic capacitors were produced by the same method as used in Example 1, except that the $\mathrm{Al}_2\mathrm{O}_3\text{-MO-B}_2\mathrm{O}_3$ based oxide as the second sub-component with a mean particle size of 1 $\mu\mathrm{m}$ or less produced by heating at 1200 to 1500°C as shown in TABLE 14 was added to the powder material. The size and shape of the laminated ceramic capacitor produced are the same as that produced in Example 4. The electric characteristics were measured by the same method as in Example 4, the results of which are shown in TABLE 15.

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				7	TABLE 1	4	.,,			
				The	Second S	Sub-Comp	onent			
Sample	Amount				Con	position	(mol%)			
No.	of	Al_2O_3				MO				D O
	Addition	111203	BaO	CaO	SrO	MgO	ZnO	MnO	Total	B_2O_3
1301	1	1	5	5	0	0	0	4	14	85
1302	1	20	8	0	0	0	2	0	10	70
1303	1	30	6	10	2	2	0	0	20	50
1304	1	40	0	30	0	0	5	15	50	10
1305	1	20	0	30	0	0	10	30	70	10
1306	1	1	0	5	5	24	5	0	39	60
1307	1	15	10	0	0	0	3	2	15	70
1308	1	10	10	15	0	5	0	5	35	55
1309	1	20	0	30	5	0	3	2	40	40
1310	1	30	5	35	5	0	5	0	50	20
1311	1	5	10	0	0	0	0	0	10	85
1312	1	30	5	5	0	0	0	0	10	60
1313	1	40	20	0	0	0	3	2	25	35
1314	1	60	30	0	0	0	3	2	35	5
1315	1	5	15	35	10	0	3	2	65	30
1316	1	0	15	15	0	0	0	0	30	70

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				TA	TABLE 15				
Sample	Burning	Dielectric	Dielectric Loss	Rate of Change of Capacitance	Rate of To Dependent Capac	Rate of Temperature Dependent Change of Capacitance	Resistivity	Dielectric Breakdown	Mean
No.	(°C)	Constant	tan δ (%)	AC% DC 5Kv/mm	$\Delta C/C20\%$ -25 ~ +85°C (%)	$\Delta C/C25\%$ -55 ~ +125°C (%)	$\Omega \bullet \mathrm{cm}$	voitage DC (kV/mm)	(h)
1301	1250	1860	2.4	-43	-7.2	-10.9	13.2	13	87
1302	1250	1870	2.4	-43	-7.3	-11.1	13.1	13	87
1303	1250	1900	2.5	-45	-8.1	-12.2	13.2	13	84
1304	1250	1880	2.4	-45	-7.8	-12.2	13.2	13	88
1305	1250	1890	2.4	-43	-8.0	-12.3	13.2	13	92
1306	1250	1850	2.3	-43	-7.9	-12.1	13.2	14	88
1307	1250	1870	2.5	-44	-7.5	-11.9	13.2	13	96
1308	1250	1880	2.5	-45	6.7-	-12.2	13.3	13	88
1309	1250	1790	2.3	-43	-7.3	-11.8	13.2	14	92
1310	1250	1830	2.3	-42	-8.0	-12.1	13.2	13	87
1311	1350	1780	3.7	-41	-7.8	-11.8	11.5	11	3
1312	1350	1560	4.5	-41	-7.1	-11.4	10.9	10	2
1313	1350	1630	5.1	-43	-7.8	-11.7	11.1	10	1
1314	1350	1810	3.5	-48	-8.4	-12.1	11.2	111	2
1315	1350	1650	5.7	-44	7.7-	-11.9	11.1	11	4
1316	1250	1820	4.8	-47	-8.1	-12.5	11.4	12	5

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As is evident from TABLE 14 and TABLE 15, the sample Nos. 1301 to 1310, in which $\mathrm{Al_2O_3}\text{-MO-B_2O_3}$ based oxides with compositions within the area surrounded by the straight lines connecting between the succeeding two points represented by A (x = 1, y = 14, z = 85), B (x =20, y = 10, z = 70), C(x = 30, y = 20, z = 50), D(x =40, y = 50, z = 10), E(x = 20, y = 70, z = 10) and F(x = 10)1, y = 39, z = 60) or on the lines in a ternary composition diagram having apexes represented by each component Al_2O_3 , MO and B_2O_3 are added, have a dielectric constant of as large as 1790 or more, the rate of temperature dependent changes of the electrostatic capacitance satisfy the B-grade characteristic standard prescribed in the JIS standard in the temperature range from -25°C to +85°C, and satisfy the X7R-grade characteristic standard prescribed in the EIA standard in the temperature range from -55°C to +125°C. In addition, the rate of change of the capacitance when a DC voltage of 5 kV/mm is impressed is as small as within 45%, the change of the electrostatic capacitance being small when used as thin layers. The mean lifetime under the high temperature load test is as long as 84 hours or more, enabling a firing temperature of 1250°C.

When the content of the Al_2O_3 -MO- B_2O_3 based oxide is out of the range of the present invention as in the sample Nos. 1311 to 1316, on the contrary, sintering is insufficient or electric characteristics are deteriorated due to plating after firing, shortening the mean lifetime in the high temperature load test.

From the results obtained by analyzing the in the dielectric ceramic particles under a transmission electron microscope with respect to the samples having the compositions within the range of the present

invention obtained in Examples 4 to 7, it was confirmed that all the samples have core-shell structures in which the Re components (Re represents Y, Gd, Tb, Dy, Ho, Er and Yb) are diffused in the vicinity of or at the grain boundaries.

Accordingly, the present invention provides a highly reliable and plating solution resistive ceramic capacitor using Ni or a Ni alloy for the inner electrodes.

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WHAT IS CLAIMED IS:

1. A dielectric ceramic comprising $(\text{Ba}_{1\text{-}x}\text{Ca}_x\text{O})_\text{m}\text{TiO}_2 + \alpha\text{Re}_2\text{O}_3 + \beta\text{MgO} + \gamma\text{MnO}$ in which Re is at least one member selected from the group consisting of Y, Gd, Tb, Dy, Ho, Er and Yb; α , β γ , m and x are molar ratios; 0.001 $\leq \alpha \leq$ 0.10; 0.001 $\leq \beta \leq$ 0.12; 0.001 $< \gamma \leq$ 0.12; 1.000 < m \leq 1.035; and 0.005 < x \leq 0.22, and

about 0.2 to 5.0 parts by weight of either a first sub-component or a second sub-component or a third sub-component relative to 100 parts by weight of $(Ba_{1-x}Ca_xO)_mTiO_2$, wherein

the $(Ba_{1-x}Ca_xO)_mTiO_2$ contains about 0.02% by weight or less of alkali metal oxides,

the first sub-component is a $\text{Li}_2\text{O-}(\text{Si},\text{Ti})\text{O}_2\text{-MO}$ oxide in which M is at least one of Al and Zr,

the second sub-component is a SiO_2-TiO_2-XO oxide in which X is at least one selected from the group consisting of Ba, Ca, Sr, Mg, Zn and Mn, and the third sub-component is SiO_2 .

- 2. A dielectric ceramic according to Claim 1, wherein the ${\rm (Ba_{1-x}Ca_xO)_mTiO_2}$ has a mean particle size of about 0.1 to 0.7 μm .
- 3. A dielectric ceramic according to Claim 1, wherein the first sub-component is present and comprises $xLiO_2-y(Si_wTi_{1-w})O_2-zMO$, x, y and z are molar percentages and $30 \le w \le 1.0$, and is within the area surrounded by the straight lines connecting between the succeeding two points represented by A (x = 20, y = 80, z = 0), B (x = 20, y = 80, z = 0)

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10, y = 80, z = 10), C (x = 10, y = 70, z = 20), D (x = 35, y = 45, z = 20), E (x = 45, y = 45, z = 10) and F (x = 45, y = 55, z = 0) or on said lines in a ternary composition diagram having apexes represented by the components LiO_2 , (Si_wTi_{1-w}) O_2 and MO, provided that when the component is on the line A-F, $0.3 \le w < 1.0$.

- 4. A dielectric ceramic according to Claim 3, wherein comprising at least one of Al_2O_3 and ZrO_2 in a combined amount of about 20 parts by weight or less and in which the ZrO_2 is 10 parts by weight or less relative to 100 parts by weight of the Li_2O -(Si,Ti) O_2 -MO oxide.
- 5. A dielectric ceramic according to Claim 3, wherein said points are A (x = 0, y = 20, z = 80), B (x = 19, y = 1, z = 80), C (x = 49, y = 1, z = 50), D (x = 45, y = 50, z = 5), E (x = 20, y = 75, z = 5) and F (x = 0, y = 80, z = 20) and wherein the $(Ba_{1-x}Ca_xO)_mTiO_2$ has a mean particle size of about 0.1 to 0.7 μm .
- 6. A dielectric ceramic according to Claim 1, wherein the second sub-component is present and comprises $xSiO_2-yTiO_2-zXO$, x, y and z are molar percentages, and is within the area surrounded by the straight lines connecting between the succeeding two points represented by A (x = 85, y = 1, z = 14), B (x = 35, y = 51, z = 14), C (x = 30, y = 20, z = 50) and D (x = 39, y = 1, z = 60) or on said lines in a ternary composition diagram having apexes represented by the components SiO_2 , TiO_2 and XO.
- 7. A dielectric ceramic according to Claim 6, comprising at least one of ${\rm Al}_2{\rm O}_3$ and ${\rm ZrO}_2$ in a combined

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amount of about 15 parts by weight or less and the $\rm ZrO_2$ is 5 parts by weight or less relative to 100 parts by weight of the $\rm SiO_2\text{-}TiO_2\text{-}XO$ oxide.

- 8. A dielectric ceramic according to Claim 6, wherein said points are A (x = 1, y = 14, z = 85), B (x = 20, y = 10, z = 70), C (x = 30, y = 20, z = 50), D (x = 40, y = 50, z = 10), E (x = 20, y = 70, z = 10) and F (x = 1, y = 39, z = 60) and wherein the $(Ba_{1-x}Ca_xO)_mTiO_2$ has a mean particle size of about 0.1 to 0.7 μ m.
- 9. A dielectric ceramic according to Claim 1 in which the third sub-component is present.
- 10. A dielectric ceramic according to Claim 2, wherein the molar ratio of (Ba + Ca)/Ti is about 0.99 to 1.035.
- a plurality of inner dielectric layers comprising Ni or a Ni alloy and existing among a plurality of said dielectric layers; and

external electrodes in electrical continuity to a plurality of said inner dielectric layers and being on the surface of said ceramic capacitor.

12. A laminated ceramic capacitor according to Claim 11, wherein said external electrodes comprise a sintered layer of conductive metal powder or conductive metal powder and glass frit.

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13. A laminated ceramic capacitor having:
a plurality of dielectric layers containing the dielectric ceramic according to Claim 2;

a plurality of inner dielectric layers comprising Ni or a Ni alloy and existing among a plurality of said dielectric layers; and

external electrodes in electrical continuity to a plurality of said inner dielectric layers and being on the surface of said ceramic capacitor.

- 14. A laminated ceramic capacitor according to Claim 13, wherein said external electrodes comprise a sintered layer of conductive metal powder or conductive metal powder and glass frit.

a plurality of inner dielectric layers comprising Ni or a Ni alloy and existing among a plurality of said dielectric layers; and

external electrodes in electrical continuity to a plurality of said inner dielectric layers and being on the surface of said ceramic capacitor.

- 16. A laminated ceramic capacitor according to Claim 15, wherein said external electrodes comprise a sintered layer of conductive metal powder or conductive metal powder and glass frit.

a plurality of inner dielectric layers

comprising Ni or a Ni alloy and existing among a
plurality of said dielectric layers; and
external electrodes in electrical
continuity to a plurality of said inner dielectric layers
and being on the surface of said ceramic capacitor.

- 18. A laminated ceramic capacitor according to Claim 17, wherein said external electrodes comprise a sintered layer of conductive metal powder or conductive metal powder and glass frit.
- 19. A laminated ceramic capacitor having:

 a plurality of dielectric layers

 containing the dielectric ceramic according to Claim 9;

 a plurality of inner dielectric layers

 comprising Ni or a Ni alloy and existing among a

 plurality of said dielectric layers; and

 external electrodes in electrical

 continuity to a plurality of said inner dielectric layers

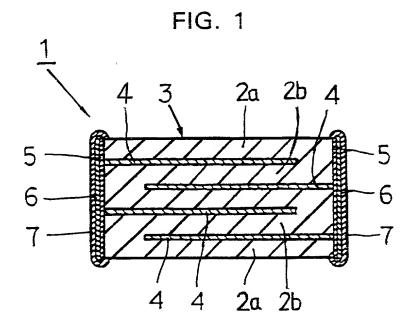
 and being on the surface of said ceramic capacitor.
- 20. A laminated ceramic capacitor according to Claim 19, wherein said external electrodes comprise a sintered layer of conductive metal powder or conductive metal powder and glass frit.

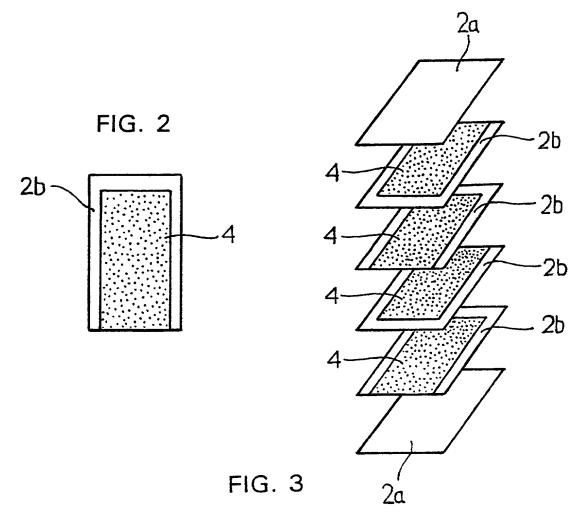
P/1071-814

DIELECTRIC CERAMIC COMPOSITION AND LAMINATED CERAMIC CAPACITOR USING THE SAME

ABSTRACT OF THE DISCLOSURE

Provided is a highly reliable laminated ceramic capacitor in which decrease of dielectric constant under a high electric field is small and which satisfies the B-grade and X7R grade characteristics, using Ni for the inner electrodes, wherein the dielectric material contains about 0.2 to 5.0 parts by weight of Li₂O-(Si, Ti)₂-MO oxides (MO is at least one of the compounds of Al₂O₃ and ZrO₂) or SiO₂-TiO₂-XO oxides (XO is at least one of the compounds of BaO, CaO, SrO, MgO, ZnO and MnO) relative to 100 parts by weight of a principal component represented by $(Ba_{1-x}Ca_xO)_mTiO_2 + \alpha Re_2O_3 + \beta MgO + \gamma MnO (Re₂O₃ represents at least one of Y₂O₃, Gd₂O₃, Tb₂O₃, Dy₂O₃, Ho₂O₃, Er₂O₃ and Yb₂O₃).$





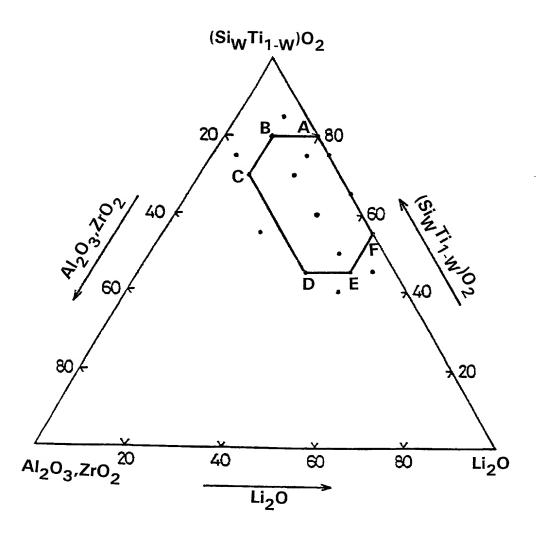


FIG. 4

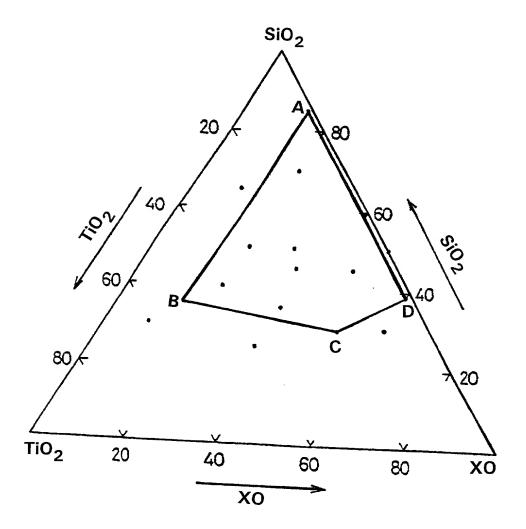


FIG. 5

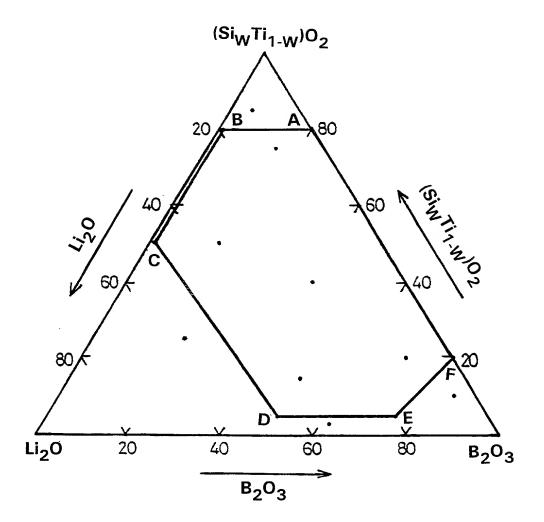


FIG. 6

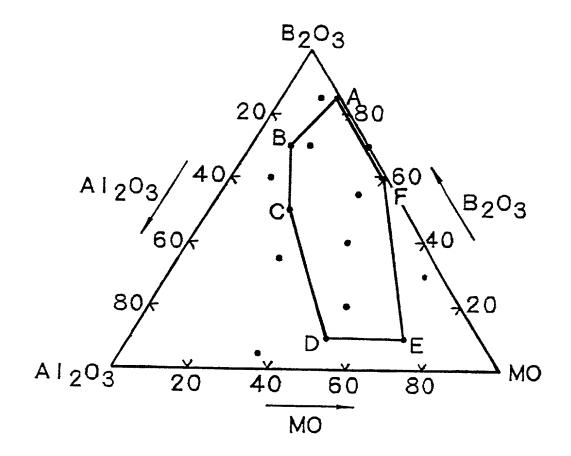


FIG. 7

COMBINED DECLARATION	UNITED STATES OF AMERICA N AND POWER OF ATTORNEY FOR PA	ATENT APPLICATION		OFGS FILE NO. P/1071-814								
As a below named inventor, I he verily believe that I am the original, the subject matter which is claimed a	ereby declare that: my residence, post office first and sole inventor (if only one name is and for which a patent is sought on the inve	e address and citizenship are s listed below) or a joint invention entitled:	e as stated belo entor (if plural	ow next to my name; that I inventors are named) of								
DIELECTRIC CERAMI	C COMPOSITION AND LA	AMINATED CERA	MIC CAF	PACITOR USING								
THE SAME	l hereto, unless the following box is checke											
_	as United S		ımber or PCT	International patent								
	and was amend											
I hereby state that I have reviewed amendment referred to above. I acknowledge the duty to disclose	ed and understand the contents of the above se all information known to be material to p	e identified specification, inc	cluding the clai	ims, as amended by any								
I hereby claim priority benefits u	under Title 35, United States Code §119 of (s) listed below and have also identified below.	any foreign application(s) for	or natent or in	ventor's certificate or								
Prior Foreign or Provisional Applica	tion(s)											
COUNTRY	APPLICATION NUMBER	DATE OF FILE (day, month, ye	NG ear)	PRIORITY CLAIMED UNDER 35 U.S.C. 119								
Japan	10-227202	August 11, 1		YES <u>X</u> NO								
Japan	10-227203	August 11, 1	998	YES X NO								
				YES NO								
Title 35. United States Code, 8112. I	Title 35, United States Code, §120 of any tapplication is not disclosed in the prior Unit I acknowledge the duty to disclose informaticame available between the filing date of the	ted States application in the	manner provid	led by the first paragraph of								
UNITED STATES APPLICATION NUMBER	DATE OF FILING (day, month, year)		Instanted	STATUS pending, abandoned)								
	(way, moment, year)		(ригетец,	penaing, avanaonea)								
Lieberstein - Reg. No. 22,400: Steve	152 OSTROLENK, FABER, GERB & SOF No. 20,345; Robert C. Faber - Reg. No. 22 en I. Weisburd - Reg. No. 27,409; Max Mc William O. Gray, III - Reg. No. 30,944; I ower of substitution and revocation to prose th and to receive all correspondence.	4,322; Edward A. Meilman	- Reg. No. 24	1,735; Stanley H.								
SEND CORRESPONDENCE TO: OSTROLENK, FABER, GERB & SOFFEN, LLP 1180 AVENUE OF THE AMERICAS NEW YORK, NEW YORK 10036-8403 CUSTOMER NO. 2352 I hereby declare that all statements made herein of my own knowledge are true and that all statements made on information and belief are												
by fine or imprisonment, or both, unvalidity of the application or any pate	these statements were made with the knowledger Section 1001 of Title 18 of the United Section 18	edge that willful talca staten	ants and tha li	ilea aa maada ama muudahahila								
FULL NAME OF SOLE OR FIRST INVENT NODUYUKI WADA	TOR INVENTOR'S SIGNA	TURE	DATE									
RESIDENCE (City and either State or F Yasu-gun, Shiga-k	*		INTRY OF CITIZ	ZENSHIP								
POST OFFICE ADDRESS C/o (A170) Intellectu	ual Property Department,	Murata Manufac	turing C	o Ltd., 26-								
10, Tenjin 2-chome, N	Nagaokakyo-shi, Kyoto-fu	. 617-8555, Japa	n									
FULL NAME OF SECOND JOINT INVENT Masamitsu SHIBATA		TURE	DATE									
RESIDENCE (City and either State or F Kyoto-shi, Kyoto-		1	NTRY OF CITIZ	ENSHIP								
10, Tenjin 2-chome, N	aal Property Department, Nagaokakyo-shi, Kyoto-fu	Murata Manufac 617-8555, Japa	turing Co	o., Ltd., 26-								
FULL NAME OF THIRD JOINT INVENTOR Takashi HIRAMATSU		TURE	DATE									
RESIDENCE (City and either State or F Yasu-gun, Shiga-ke			NTRY OF CITIZ pan	ENSHIP								
POST OFFICE ADDRESS												
c/o (A170) Intellectu 10, Tenjin 2-chome, N	ıal Property Department, Nagaokakyo-shi, Kyoto-fu	Murata Manufaci 617-8555, Japan	curing Co	o., Ltd., 26-								

-	UNITED STATES OF AMERICA COMBINED DECLARATION AND POWER OF ATTORNEY FOR PATENT APPLICATION				OFGS FILE NO. P/1071-814	
	COUNTRY	APPLICATION NUMBER	DATE OF FILI (day, month, ye	ING	PRIORITY CLAIMED UNDER 35 U.S.C. 119	
1					YES NO	
ļ					YES NO	
					YES NO	
J				***	YES NO	
				-	YES NO	
					YES NO	
					YES NO	
-					YES NO	
					YES NO	
					YES NO	
					YES NO	
					YES NO	
Samp Samp	I hereby declare that all statements made herein of my own knowledge are true and that all statements made on information and belief are believed to be true; and further that these statements were made with the knowledge that willful false statements and the like so made are punishable by fine or imprisonment, or both, under Section 1001 of Title 18 of the United States Code and that such willful false statements majeopardize the validity of the application or any patent issued thereon. FULL NAME OF FOURTH JOINT INVENTOR, IF ANY INVENTOR'S SIGNATURE DATE					
in had	Yukio HAMAJI		INVENTOR'S SIGNATURE		DATE	
the think of	RESIDENCE (City and either State or Fo Otsu-shi, Shiga-ke			country Japa:	Y OF CITIZENSHIP .D	
the state of the s	POST OFFICE ADDRESS c/o (A170) Intellectual Property Department, Murata Manufacturing Co., Ltd., 26- 10, Tenjin 2-chome, Nagaokakyo-shi, Kyoto-fu 617-8555, Japan					
	FULL NAME OF FIFTH JOINT INVENTOR, IF ANY		INVENTOR'S SIGNATURE		DATE	
	RESIDENCE (City and either State or Foreign Country)			COUNTRY OF CITIZENSHIP		
The state of the s	POST OFFICE ADDRESS					
	FULL NAME OF SIXTH JOINT INVENTOR, IF ANY		INVENTOR'S SIGNATURE		DATE	
	RESIDENCE (City and either State or Foreign Country)			COUNTRY OF CITIZENSHIP		
	POST OFFICE ADDRESS					
	FULL NAME OF SEVENTH JOINT INVENTOR, IF ANY		INVENTOR'S SIGNATURE		DATE	
	RESIDENCE (City and either State or Foreign Country)			COUNTRY	Y OF CITIZENSHIP	
	POST OFFICE ADDRESS	POST OFFICE ADDRESS				